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One Buck, One Boost and Four LDO PMIC

General Description

The FAN53880 is a low quiescent current PMIC for mobile power applications. The PMIC contains one buck, one boost, and four low noise LDOs.

The buck and boost converters can operate within a wide supply range of 2.5 V to 5.5 V. At moderate and light loads, Pulse Frequency Modulation (PFM) reduces current consumption while maintaining excellent transient response during load swings. At higher loads, the converters automatically switch to Pulse Width Modulation (PWM) control.

The FAN53880 is available in a 25-bump, 0.4 mm pitch, Wafer-Level Chip-Scale Package (WLCSP).

Features

- Programmable Start–Up/Down Sequencing
- Programmable Output Voltages
- Soft-Start (SS) Inrush Current Limiting
- Fault Protection with Interrupt Reporting
 - UVLO, OCP, OVP, UVP and OTP
- Low Current Standby and Shutdown Modes
- Buck Converter:
 - Input Voltage Range: 2.5 V to 5.5 V
 - Digitally Programmable Voltage Range: 0.6 V to 3.3 V
 - 1200 mA Output Current Capability
- ♦ 95% Efficiency
- Boost Converter:
 - Input Voltage Range: 2.5 V to 5.5 V
 - Digitally Programmable Voltage Range: 3.0 V to 5.7 V
 - 1000 mA Output Current Capability
 - ◆ 95% Efficiency
- Four LDOs:
 - Input Voltage Range: 1.9 V to 5.5 V
 - Digitally Programmable Voltage Range: 0.8 V to 3.3 V
 - ◆ 300 mA Output Current Capability

Applications

- Smartphones and Tablets
- Compact Camera Modules
- USB On-The-Go



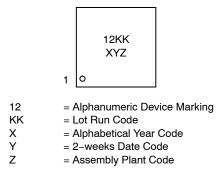
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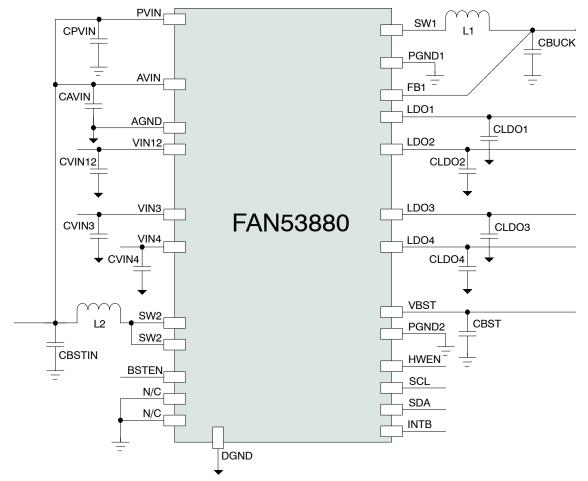


WLCSP25 CASE 567QT

MARKING DIAGRAM



Application Diagram





PART NUMBERING

Table 1. ORDERING INFORMATION

Part Number	Buck V _{OUT}	LDO1,2 V _{OUT}	LDO3,4 V _{OUT}	Boost V _{OUT}	l2C Address	Temperature Range	Package	Packing Method	Device Marking
FAN53880UC001X*	1.1 V	2.8 V	1.8 V	5.0 V	7'h35	-40°C to 85°C	25–Bump WLCSP	Tape and Reel [†]	LT
FAN53880UC002X	1.1 V	2.8 V	1.8 V	5.0 V	7'h35	-40°C to 85°C	25–Bump WLCSP	Tape and Reel [†]	LW

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

*Not recommended for new designs.

PVIN

(A2)

FB1 B2 HWEN C2 FIN3 D2 LD03

(E2)

SW1

(A1

PGND1

E1

PRODUCT PIN ASSIGNMENTS

Pin Configuration

Figure 2. Pin Configuration

Pin Descriptions

Table 2. PIN DEFINITION

A1 SW1 Switching node of the buck converter. Tie one lead of the inductor to this pin. A2 PVIN Input power for the buck and boost converter. Bypass this pin with C _{PVIN} close to the device pin. The voltage must be kept within 25 mV of AV _{IN} . A3 VBST Boost output node. Locate C _{BST} close to this pin A4, A5 SW2 Switching node for the boost converter. B1 PGND1 Power ground connection for the buck converter. Connect directly to ground plane. B2 FB1 Feedback pin for the buck converter. Connect to C _{BUCK} and keep trace away from noisy circuitry. B3 BSTEN Enables the boost and critical circuits associated with the boost operation when asserted high. The E pin has an internal 2.8 MΩ pull-down and should always be connected to a logic high or low. Note: HWEN does not need to be high for Boost operation when BSTEN is high. B4 INTB I2C interrupt pin is active low indicating that an interrupt event has occurred. B5 PGND2 Power ground connection for the Boost converter. Connect directly to ground, but is not nec C2 HWEN This pin is a no-connect within the device. It is recommended to ite this pin to ground, but is not nec C3 DGND Digital/Analog ground connection. Tie to inner layer power plane through via. C4 SDA	
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	dded
D5 VIN12 This is the input power pin for LDO1 and LDO2. Place C _{VIN12} as close to this pin as possible.	essary.
E1 LDO4 This is the output pin for LDO4. Place C _{LDO4} as close to this pin as possible.	
E2 LDO3 This is the output pin for LDO3. Place C _{LDO3} as close to this pin as possible.	
E3 AGND Analog ground is the analog circuitry ground. Tie this pin to the analog ground plane.	
E4 LDO2 This is the output pin for LDO2. Place C _{LDO2} as close to this pin as possible.	
E5 LDO1 This is the output pin for LDO1. Place C _{LDO1} as close to this pin as possible.	

PRODUCT BLOCK DIAGRAM

Block Diagram

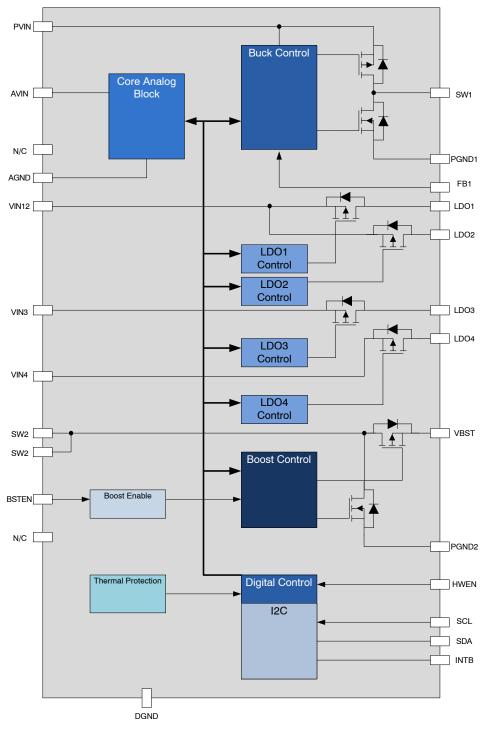




Table 3. ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Conditions	Min	Тур	Max	Units
V _{IN}	Input Voltage	$\text{AV}_{\text{IN}},\text{PV}_{\text{IN}},\text{V}_{\text{IN12}},\text{V}_{\text{IN3}}\text{and}\text{V}_{\text{IN4}}$	-0.3		(Note 1)	V
V _{SW1}	Voltage on SW1 Pin		-0.3		(Note 1)	V
V _{SW2}	Voltage on SW2 Pin		-0.3		(Note 1)	V
V _{CTRL}	SDA and SCL Pins		- 0.3		(Note 1)	V
V _{INTB}	INTB Pins		- 0.3		AV _{IN}	V
	other Pins		- 0.3		(Note 1)	V
ESD	Electrostatic Discharge Protection	Human Body Model		2.0		kV
	Level	Charged Device Model		500		V
TJ	Junction Temperature		-40		+150	°C
T _{STG}	Storage Temp		-40		+150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected. 1. Lesser of 6 V or AV_{IN} + 0.3 V.

Table 4. THERMAL PROPERTIES

Ī	Symbol	Parameter	Typical	Unit
ſ	θ_{JA}	Junction-to-Ambient Thermal Resistance	58	°C/W

NOTE: Junction-to-ambient thermal resistance is a function of application and board layout. This data is measured with two-layer 2s2p boards in accordance to JEDEC standard JESD51. Special attention must be paid not to exceed junction temperature T_{J(max)} at a given ambient temperature T_A.

Table 5. RECOMMENDED OPERATING CONDITIONS

Symbol	Parameter	Conditions	Min	Тур	Max	Units
AP _{VIN}	Supply Voltage Range	AV _{IN} , PV _{IN}	2.5		5.5	V
V _{IN12}		V _{IN12}	2.5		5.5	V
V _{IN3}		V _{IN3}	1.9		5.5	V
V _{IN4}		V _{IN4}	1.9		5.5	V
PD	Power Dissipation	$PD = (125^{\circ}C - 85^{\circ}C) / 58^{\circ}C/W = 0.69 W$			0.69	W
T _A	Operating Ambient Temperature		-40		85	°C
TJ	Junction Temperature		-40		125	°C

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

Table 6. ELECTRICAL CHARACTERISTICS

Symbol	Parameter	Conditions	Min	Тур	Max	Units
POWER SUPPLI	ES UVLO					
V _{VIN UVLO_RISE}	Under-Voltage Lockout	Rising AV _{IN} or V _{IN12}	2.30	2.35	2.45	V
V _{VIN UVLO_FALL}	Threshold	Falling AV _{IN} or V _{IN12}	2.15	2.25	2.30	V
VVIN3/4 UVLO_RISE		Rising V_{IN3} and V_{IN4}	1.80	1.85	1.95	V
VVIN3/4 UVLO_FALL		Falling V_{IN3} and V_{IN4}	1.70	1.75	1.80	V
BUCK EC	•	•	•	•	•	
POWER SUPPLI	ES					
IQ _{BK_PFM}	PFM Quiescent Current	Total current on PV_{IN} and AV_{IN} when $AV_{IN} = PV_{IN} = VHWEN$, BUCK_EN bit = 1, PFM Mode, Non Switching, No Load, all other converters disabled.		36		μΑ
R _{BK_DIS}	Output Discharge Resistance		80	100	120	Ω
PFM ↔ PWM TH	RESHOLDS					
I _{BK_PFM}	I _{OUT} where part transitions into PFM			50		mA
I _{BK_PWM}	I _{OUT} value where part transi- tions into PWM			120		mA
BUCK V _{OUT} ACC	URACY					•
VO _{BK_ACC}	PFM Output Voltage Accuracy	V_{OUT} = 0.6 V, AV_{IN} = PV_{IN} = 3.8 V, PFM Mode, I_{OUT} = 0 A	-3		3	%
			-2		2	%
	PWM Output Voltage Accuracy	V_{OUT} = 0.6 V, AV_{IN} = PV_{IN} = 3.8 V, PWM Mode, I_{OUT} = 0 A	-3		3	%
		$AV_{IN} = PV_{IN} = 3.8V$, No Load, PWM Mode, $V_{OUT} = 1.0125$ V to 3.3 V	-2		2	%
CURRENT LIMIT					•	
ILIM _{BK}	Peak Inductor Current Limit	Programmed to support 1.2 A DC load	1600	1900	2200	mA
REGULATOR					-	
F _{BK_SW}	Switching Frequency	$\begin{array}{l} PWM, \ I_{OUT} = 0 \ A, \ AV_{IN} = PV_{IN} = 3.8 \ V, \\ V_{OUT} = 1.1 \ V \end{array}$	2.25	2.5	2.75	MHz
RDS _{ON BK_P}	PMOS Resistance Ball-to-Ball	$AP_{VIN} = V_{GS} = 3.8 \text{ V}, \text{ Temp} = 25^{\circ}\text{C}$		0.125	0.200	Ω
RDS _{ON BK_N}	NMOS Resistance Ball-to-Ball	$AP_{VIN} = V_{GS} = 3.8 \text{ V}, \text{ Temp} = 25^{\circ}\text{C}$		0.085	0.140	Ω
VO _{BK_RNG}	Buck Output Voltage Range	When V _{OUT} + 300 mV < AV _{IN} & PV _{IN}	0.6	1.1	3.3	V
ВИСК ОИТРИТ Р	PROTECTION					
OVP _{BK_RS}	Rising Over Voltage Output Threshold	V _{IN} = 3.8 V, V _{OUT} = 1.1 V, V _{OUT} = 2.85 V	Vtarget x 1.17	Vtarget x 1.2	Vtarget x 1.23	V
		V _{OUT} = 0.6 V	Vtarget x 1.15	Vtarget x 1.2	Vtarget x 1.25	V
OVP _{BK_FL}	Falling Over Voltage Output Threshold	V _{OUT} = 0.6 V to 3.300V	Vtarget x 1.04	Vtarget x 1.10	Vtarget x 1.14	V
UVP _{BK_FL}	Falling Under Voltage Output Threshold	V _{OUT} = 0.6 V	Vtarget x 0.83	Vtarget x 0.90	Vtarget x 0.97	V
		V _{IN} = 3.8 V, V _{OUT} = 1.1 V, 2.85 V	Vtarget x 0.86	Vtarget x 0.90	Vtarget x 0.93	V
UVP _{BK_RS}	Rising Under Voltage Output Threshold	V _{OUT} = 0.6 V to 3.3 V	Vtarget x 0.90	Vtarget x 0.95	Vtarget x 0.99	V

Table 6. ELECTRICAL CHARACTERISTICS (continued)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
OVP _{BK_TMR}	Over Voltage Output Protection Timer	V_{OUT} Target = 2.85 V, V_{OUT} held at 3.65 V, INTB going high trigger	32	40	56	μs
UVP _{BK_TMR}	Under Voltage Output Protec- tion Timer	$V_{OUT Target} = 2.85 V$, V_{OUT} held at 2.05 V, Time to Output Disabled	32	40	56	μs

BOOST EC

POWER SUPPLIES

IQ _{BST_PFM}	Quiescent Current	Total current on PV_{IN} and AV_{IN} , $V_{OUT} = 5 V$ when $V_{BSTEN} = AV_{IN}$, VHWEN = 0, PFM Mode, Non Switching, No Load, all other converters disabled.		32	44	μΑ
IQ _{BST PT}	IQ in Auto Pass-Thru Mode	Total current on PV_{IN} and AV_{IN} when $V_{BSTEN} = AV_{IN}$, VHWEN = 0, No Load, all other converters disabled.		39	90	μΑ
IQ _{BST_FPT}	IQ when part is in Forced Pass-Thru Mode	Total current on PV_{IN} and AV_{IN} when $AV_{IN} = PV_{IN} = V_{BSTEN} = 3.8 V$, VHWEN = 0, BST_MODE bit = 1, No Load, all other converters disabled.		18		μΑ
R _{BST_DCHG}	Output Discharge Resistance		80	100	120	Ω
PFM ↔ PWM TH	RESHOLDS					
I _{BST_PFM}	PFM Mode I _{OUT} Threshold			100		mA
I _{BST_PWM}	PWM Mode I _{OUT} Threshold			130		mA
BOOST VOUT AC	CURACY					
VO _{BST_ACC}	PFM Output Voltage Accuracy	V _{IN} = 3.8 V, No Load, PFM Mode	-3		3	%
	PWM Output Voltage Accuracy	V _{IN} = 3.8 V, No Load, PWM Mode	-3		3	%
CURRENT LIMIT			•		•	•
I _{LIMBST}	Peak Inductor Current Limit	Programmed to support 1 A DC load	3.0	3.5	4.0	А
REGULATOR						
F _{SW_BST}	PWM Switching Frequency	V _{IN} = 3.8 V	2.25	2.5	2.75	MHz
RDS _{ON BST_P}	PMOS Resistance Ball-to-Ball	Temp = 25°C		65	120	mΩ
RDS _{ON BST_N}	NMOS Resistance Ball-to-Ball	Temp = 25°C		50	100	mΩ
VO _{BST_RNG}	Boost Output Voltage Range	When PV_{IN} < V_{BST} and 2.5 V \leq $\text{PV}_{\text{IN}}/\text{AV}_{\text{IN}}$ \leq 5.5 V	3.0	5.0	5.7	V

BOOST OUTPUT PROTECTION

OVP _{BST_RS}	Rising Over Voltage Output Threshold	V _{AVIN} = 3.8 V, V _{OUT} = 5.0 V	Vtarget x 1.16	Vtarget x 1.2	Vtarget x 1.22	V
OVP _{BST_FL}	Falling Over Voltage Output Threshold		Vtarget x 1.07	Vtarget x 1.1	Vtarget x 1.12	V
UVP _{BST_FL}	Falling Under Voltage Output Threshold	V _{AVIN} = 3.8 V, V _{OUT} = 5.0 V	Vtarget x 0.78	Vtarget x 0.80	Vtarget x 0.82	V
UVP _{BST_RS}	Rising Under Voltage Output Threshold		Vtarget x 0.88	Vtarget x 0.90	Vtarget x 0.93	V
OVP _{BST_TMR}	Over Voltage Output Protection Timer	V _{OUT_Target} = 5.0 V, V _{OUT} held at 6.25 V, INTB going high trigger	32	40	56	μs
UVP _{BST_TMR}	Under Voltage Output Protec- tion Timer	$V_{OUT Target} = 5.0 V$, V_{OUT} held at 4.00 V, Time to Output Disabled	32	40	56	μs

Table 6. ELECTRICAL CHARACTERISTICS (continued)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
LDO1/2 EC SPECS	6					

QUIESCENT CURRENT

IQ _{L12}	Quiescent Current, No Load	I_{OUT} = 0 A, Combined Current Measured at AV _{IN} and V _{IN12} when LDO1 is enabled only or LDO2 is enabled only, Buck and Boost are disabled, VHWEN = AV _{IN}		40	55	μΑ
VO _{L12_RNG}	LDO Output Voltage Range	When V_{OUT} + 300 mV < V_{IN12} and 2.5 V \leq V_{IN12} \leq 5.5 V	0.8	2.8	3.3	V
VO _{L12_ACC}	Output Voltage Accuracy	I_{OUT} = 300 mA, AV _{IN} = V _{IN12} = 3.8 V, V _{OUT} = 0.8 V to 3.3 V	-2.0		+2.0	%
V _{L12_DO}	Dropout Voltage	$V_{OUT} = V_{OUT_TARGET} - 100 \text{ mV}, I_{OUT} = 300 \text{ mA}, V_{OUT_TARGET} = 2.8 \text{ V}$			250	mV
IO _{MAX_L12}	Max load current	V_{OUT} + 0.3 V < V_{IN12} and V_{IN12} = 2.5 V to 4.5 V	300			mA

CURRENT LIMIT

I _{LIM_L12}	V_{OUT} + 500 mV < V_{IN12} and 2.5 V \leq V_{IN12} \leq 4.5 V		180	210	mA
	V_{OUT} + 500 mV < V_{IN12} and 2.5 V $\leq V_{IN12} \leq$ 4.5 V	360	420	480	mA

OUTPUT PROTECTION

OVP _{L12_RS}	Rising Over Voltage Output Threshold	$V_{AVIN} = V_{IN1/2} = 3.8 \text{ V}, V_{OUT} = 2.8 \text{ V}$	Vtarget x 1.17	Vtarget x 1.2	Vtarget x 1.23	V
OVP _{L12_FL}	Falling Over Voltage Output Threshold	V _{AVIN} = V _{IN1/2} = 3.8 V, V _{OUT} = 2.8 V	Vtarget x 1.07	Vtarget x 1.1	Vtarget x 1.12	V
UVP _{L12_FL}	Falling Under Voltage Output Threshold	V _{AVIN} = V _{IN1/2} = 3.8 V, V _{OUT} = 2.8 V	Vtarget x 0.77	Vtarget x 0.8	Vtarget x 0.82	V
UVP _{L12_HS}	Rising Under Voltage Output Threshold	V _{AVIN} = V _{IN1/2} = 3.8 V, V _{OUT} = 2.8 V	Vtarget x 0.88	Vtarget x 0.9	Vtarget x 0.93	V
OVP _{L12_TMR}	Over Voltage Output Protection Timer	V _{OUT_Target} = 2.8 V, V _{OUT} held at 3.5 V, INTB going high trigger	32	40	56	μs
UVP _{L12_TMR}	Under Voltage Output Protec- tion Timer	V _{OUT_Target} = 2.8 V, V _{OUT} held at 1.8 V, Time to Output Disabled	32	40	56	μs
R _{L12_DCHG}	Output Discharge Resistance		80	100	120	Ω

LDO3/4 EC SPECS

QUIESCENT CURRENT

IQ _{L34}	Quiescent Current, No Load	$\begin{array}{l} I_{OUT} = 0 \text{ A, Combined Current Measured} \\ \text{at AV}_{\text{IN}} \text{ and V}_{\text{IN3}} \text{ when LDO3 is enabled or} \\ \text{AV}_{\text{IN}} \text{ and V}_{\text{IN4}} \text{ when LDO4 is enabled.} \\ \text{LDO1, LDO2, Buck and Boost are disabled, VHWEN = AV}_{\text{IN}} \end{array}$		38	50	μΑ
VO _{L34_RNG}	LDO3/4 Output Voltage Range	LDO3: V_{OUT} + 0.15 < V_{IN3} and V_{IN3} = 1.95 V to 4.5 V, LDO4: V_{OUT} + 150 mV < V_{IN4} and V_{IN4} = 1.95 V to 4.5 V	0.8	1.8	3.3	V
VO _{L34_ACC}	Output Voltage Accuracy	I_{OUT} = 300 mA, AV_{IN} = 3.8 V, V $_{IN3/4}$ = 3.8 V, V $_{OUT}$ = 0.8 V to 3.3 V	-2.5		+2.0	%
V _{L34_DO}	Dropout Voltage	V _{OUT} = V _{OUT_TARGET} – 100 mV, I _{OUT} = 300 mA, V _{OUT_TARGET} = 1.8 V			150	mV
IO _{MAX_L34}	Max load current	V_{OUT} + 150 mV < V_{IN3} and V_{IN3} = 1.95 V to 4.5 V, LDO4: V_{OUT} + 150 mV < V_{IN4} and V_{IN4} = 1.95 V to 4.5 V	300			mA

Table 6. ELECTRICAL CHARACTERISTICS (continued)

O	Dava	Openditi's as	Mar	T	M	11 14
Symbol	Parameter	Conditions	Min	Тур	Max	Units
CURRENT LIMIT		1	1	1	1	
I _{LIM_L34}	Current Limit	V_{OUT} + 500 mV < V_{IN3} and V_{IN3} = 1.95 V to 4.5 V, LDO4: V_{OUT} + 500 mV < V_{IN4} and V_{IN4} = 1.95 V to 4.5 V	150	180	210	mA
		V_{OUT} + 500 mV < V_{IN3} and V_{IN3} = 1.95 V to 4.5 V, LDO4: V_{OUT} + 500 mV < V_{IN4} and V_{IN4} = 1.95 V to 4.5 V	360	420	480	mA
R _{L34 DCHG}	Output Discharge Resistance		80	100	120	Ω
	CTION	1				
OVP _{L34_RS}	Rising Over Voltage Output Threshold	V _{AVIN} = 3.8 V, V _{IN3/4} = 1.95V, V _{OUT} = 1.8 V	Vtarget x 1.17	Vtarget x 1.2	Vtarget x 1.23	V
OVP _{L34_FL}	Falling Over Voltage Output Threshold	$V_{AVIN} = 3.8 \text{ V}, V_{IN3/4} = 1.95 \text{V}, V_{OUT} = 1.8 \text{ V}$	Vtarget x 1.07	Vtarget x 1.1	Vtarget x 1.12	V
UVP _{L34_FL}	Falling Under Voltage Output Threshold	V _{AVIN} = 3.8 V, V _{IN3/4} = 1.95V, V _{OUT} = 1.8 V	Vtarget x 0.77	Vtarget x 0.80	Vtarget x 0.82	V
UVP _{L34_RS}	Rising Under Voltage Output Threshold	V _{AVIN} = 3.8 V, V _{IN3/4} = 1.95V, V _{OUT} = 1.8 V	Vtarget x 0.88	Vtarget x 0.90	Vtarget x 0.93	V
OVP _{L34_TMR}	Over Voltage Output Protection Timer	V _{OUT_Target} = 1.8 V, V _{OUT} held at 2.25 V, INTB going high trigger	32	40	56	μs
UVP _{L34_TMR}	Under Voltage Output Protec- tion Timer	V_{OUT_Target} = 1.8 V, V_{OUT} held at 1.35 V, Time to Output Disabled	32	40	56	μs
O LEVELS						
VIL	HWEN Logic Low threshold				0.35	V
V _{IH}	HWEN Logic High threshold		1.2		V _{IN}	V
VIL	BSTEN Logic Low threshold				0.25	V
V _{IH}	BSTEN Logic High threshold	AV _{IN} = 4.5 V;	1.05		V _{IN}	V
R _{PD}	HWEN and BSTEN Input Resistance	V _{IN} = High or Low	1	4.4		MΩ
V _{OL_INTB}	INTB	Isink = 5 mA			0.3	V
I _{INTB}		V _{INTB} = 5.5 V			0.5	μA
Q CONDITIONS						
IQ AVIN_SD	Shutdown Supply Current	Total current on AV_{IN} when $AV_{IN} = 5.0 V$ and all xxx_EN bits = 0, xxx_SEQ bits =000, HWEN = BSTEN = SDA = SCL = Low			5	μΑ
IQ PVIN_SD		Total current on PV _{IN} when PV _{IN} = 5.0 V and all xxx_EN bits = 0, xxx_SEQ bits =000, HWEN = BSTEN = SDA = SCL = Low			1.5	μΑ
I _{Q VIN12_SD}		Total current on V _{IN12} when V _{IN12} = 5.0 V and all xxx_EN bits = 0, xxx_SEQ bits =000, HWEN = BSTEN = SDA = SCL = Low			1.5	μΑ
I _{Q VIN3_SD}		Total current on V _{IN3} when V _{IN3} = 5.0 V and all xxx_EN bits = 0, xxx_SEQ bits =000, HWEN = BSTEN = SDA = SCL = Low			1.5	μΑ
I _{Q VIN4} SD		Total current on V_{IN4} when $V_{IN4} = 5.0 V$ and all xxx_EN bits = 0, xxx_SEQ bits =000, HWEN = BSTEN = SDA = SCL = Low			1.5	μΑ

Table 6. ELECTRICAL CHARACTERISTICS (continued)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
I _{Q_STBY}	Standby Supply Current	Total current on PV_{IN} , AV_{IN} , V_{IN12} , V_{IN3} and V_{IN4} when = 5.0 V and all xxx_EN bits = 1 (Except BST_EN), xxx_SEQ bits =000, $AV_{IN} = PV_{IN} = VHWEN = V_{BSTEN}$. LDO1-4 on, Buck on, Boost on		165	190	μΑ
I _{SLP}	Sleep Supply Current	Total current on PV _{IN} , AV _{IN} , V _{IN12} , V _{IN3} and V _{IN4} when = 5.0 V and all xxx_EN bits = 0, xxx_SEQ bits =000, AV _{IN} = PV _{IN} = VHWEN, BSTEN = Low. LDO1-4 off, Buck off, Boost off, No I2C activity		12	20	μΑ

I²C Timing and Performance[†]

V _{IL}	SDA and SCL Logic Low threshold		-0.5	0.4	V
V _{IH}	SDA and SCL Logic High threshold		1.2	5.5	V
V _{OL}	SDA Logic Low Output	3 mA Sink		0.4	V
I _{OL}	SDA Sink Current		20		mA
fSCL	SCL Clock Frequency	Fast Mode Plus		1000	kHz
tBUF	Bus-Free Time Between STOP and START Conditions	Fast Mode Plus	0.5		μs
tHD;STA	START or Repeated START Hold Time	Fast Mode Plus	260		ns
tLOW	SCL LOW Period	Fast Mode Plus	0.5		μs
tHIGH	SCL HIGH Period	Fast Mode-Plus	260		ns
tSU;STA	Repeated START Setup Time	Fast Mode-Plus	260		ns
tHD;DAT	Data Hold Time	Fast Mode Plus	0		ns
tSU;DAT	Data Setup Time	Fast Mode Plus	50		ns
tVD;DAT	Data Valid Time	Fast Mode Plus		450	ns
tVD;ACK	Data Valid Acknowledge Time	Fast Mode Plus		450	ns
tR	SDA and SCL Rise Time	Fast Mode Plus		120	ns
tF	SDA and SCL Fall Time	Fast Mode Plus, VDD = 1.8 V	6.55	120	ns
tSU;STO	Stop Condition Setup Time	Fast Mode Plus	260		ns
Ci	SDA and SCL Input Capaci- tance			10	pF
Cb	Capacitive Load for SDA and SCL			550	pF
t _{SP}	Pulse width of spikes which must be suppressed by input filter	SCL, SDA only	0	50	ns

Notes: Refer to Typical Characteristics waveforms/graphs for closed loop data and variation with input supply and temperature. Electrical specifications reflects open loop steady state data. System specifications reflects both steady state and dynamic close loop data associated with the recommended external components.

Guarantee Levels:

[†] – Guaranteed by Design Only. Not Characterized or Production Tested.

Table 7. SYSTEM CHARACTERISTICS

System Specifications are guaranteed by design and are not production tested. They reflect closed loop performance using the Recommended Layout and External Components. Minimum and Maximum values are at $AV_{IN} = PV_{IN} = 2.5 V to 5.5 V \& PV_{IN} > V_{BUCK} + 350 mV$ and $PV_{IN} < V_{BST} - 250 mV$, $V_{IN12} = 2.5 V to 5.5 V \& V_{IN} > V_{LDO1/2} + 300 mV$, V_{IN3} , $V_{IN4} = 1.95 V to 5.5 V \& V_{IN3}$, $V_{IN4} > V_{LDO3/4} + 150 mV$, $V_{BUCK} = 0.6 V to 3.3 V$, $V_{BST} = 3.0 V to 5.7 V$, V_{LDO1} , V_{LDO2} , V_{LDO3} and $V_{LDO4} = 0.8 V to 3.3 V$, $T_A = -40^{\circ}C$ to $85^{\circ}C$, unless otherwise noted. Typical values are at $T_A = 25^{\circ}C$, $AV_{IN} = PV_{IN} = V_{IN12} = 3.8 V$, $V_{IN3} = V_{IN4} = 1.95 V$, $V_{BUCK} = 1.1 V$, $V_{BST} = 5.0 V$, $V_{LDO1} = V_{LDO2} = 2.8 V$, $V_{LDO3} = V_{LDO4} = 1.8 V$.

Symbol	Parameter	Conditions	Min	Тур	Max	Units
SOFT START	•		•	•		-
T _{SS BK}	Soft-Start	Time from enabling to 95% of V _{OUT} Target of 1.1 V, I_{OUT} = 300 mA and 1.2 A, Auto Mode, C_{OUT} = 10 uF, PV _{IN} = 3.0 V to 4.4 V		300	480	μs
RIPPLE						
$V_{BK PFM_RPL}$	Output Ripple	I _{OUT} = 20 mA, PFM Mode		30	40	mV
V _{BK PWM_RPL}		I _{OUT} = 200 mA, PWM Mode			10	mV
REGULATION & T	RANSIENT					
REG _{BK_LOAD}	Load Regulation	I _{OUT} = 1 mA to 1200 mA, PWM Mode	-1.5		1.5	%
REG _{BK_LINE}	Line Regulation	V _{IN} = 3.0 V to 4.4 V , I _{OUT} = 50 mA, 300 mA, and 1200 mA, PWM Mode	-0.5		0.5	%
V _{BK TR_LD}	Load Transient	I_{OUT} = 240 mA <-> 960 mA, T_{R} = T_{F} = 1 us, V_{OUT} = 1.1 V, PV_{IN} = 3.8 V, Auto Mode, Trecovery < 10 us			±70	mV
I _{OUT} MAX						
IO _{MAX_BK}	I _{OUT} Max		1200			mA
EFFICIENCY			-	•	•	
EFF _{BK}	Efficiency	I _{OUT} = 10 mA, V _{OUT} = 2.85 V, PV _{IN} = 3.8 V	92			%
		$I_{OUT} = 600 \text{ mA}, V_{OUT} = 2.85 \text{ V}, PV_{IN} = 3.8 \text{ V}$	93			%
		I _{OUT} = 1.2 A, V _{OUT} = 2.85 V, PV _{IN} = 3.8 V	90			%
		I_{OUT} = 200 mA to 600 mA, V_{OUT} = 1.1 V, PV_{IN} = 3.8 V	85			%
		I _{OUT} = 10 mA, V _{OUT} = 1.1 V, PV _{IN} = 3.8 V	84			%
		I_{OUT} = 600 mA, V_{OUT} = 1.1 V, PV_{IN} = 3.8 V	85			%
		I _{OUT} = 1.2 A, V _{OUT} = 1.1 V, PV _{IN} = 3.8 V	77			%
SOFT START						
T _{LIN_BST}	Soft Start Input Linear Current Limit			450	700	mA
T _{SS_BST}	Soft-Start	Time from enabling to 90% of V _{OUT} Target, $I_{OUT} = 100 \text{ mA}$		280	580	μs
T _{SS BST_PS}		PV _{IN} = 3.8 V, BST_MODE bit = 1, V _{OUT} = PV _{IN} (Start up into Forced Pass-Through Mode)		190	580	μs
RIPPLE			-			
V _{BST PFM_RPL}	Output Ripple	I _{OUT} = 10 mA, V _{OUT} = 5 V, PV _{IN} = 3.8 V		40	80	mV
VBST PWM_RPL		I _{OUT} = 500 mA, V _{OUT} = 5 V, PV _{IN} = 3.8 V		20	40	mV
REGULATION & T	RANSIENT					
REG _{BST_LD}	Load Regulation	I_{OUT} = 1 mA <-> 1 A, PV _{IN} = 3.8 V, V _{OUT} = 5.0 V	-1.5		+1.5	%
REG _{BST_LN}	Line Regulation	PV_{IN} = 3.0 V <-> 4.4 V , I_{OUT} = 50 mA and 1 A	-0.5		+0.5	%
V _{BST TR_LD}	Load Transient	I_{OUT} = 200 mA <-> 800 mA, T _R = T _F = 2 us, V _{OUT} = 5.0 V, PV _{IN} = 3.8 V, Trecovery < 10 us			±150	mV
I _{OUT} MAX	•	-	•			•
I _{O BST}	I _{OUT} Max		1000			mA

Table 7. SYSTEM CHARACTERISTICS (continued)

System Specifications are guaranteed by design and are not production tested. They reflect closed loop performance using the Recommended Layout and External Components. Minimum and Maximum values are at $AV_{IN} = PV_{IN} = 2.5 V to 5.5 V \& PV_{IN} > V_{BUCK} + 350 mV$ and $PV_{IN} < V_{BST} - 250 mV$, $V_{IN12} = 2.5 V to 5.5 V \& V_{IN} > V_{LDO1/2} + 300 mV$, V_{IN3} , $V_{IN4} = 1.95 V to 5.5 V \& V_{IN3}$, $V_{IN4} > V_{LDO3/4} + 150 mV$, $V_{BUCK} = 0.6 V to 3.3 V$, $V_{BST} = 3.0 V to 5.7 V$, V_{LDO1} , V_{LDO2} , V_{LDO3} and $V_{LDO4} = 0.8 V to 3.3 V$, $T_A = -40^{\circ}C$ to $85^{\circ}C$, unless otherwise noted. Typical values are at $T_A = 25^{\circ}C$, $AV_{IN} = PV_{IN} = V_{IN12} = 3.8 V$, $V_{IN3} = V_{IN4} = 1.95 V$, $V_{BUCK} = 1.1 V$, $V_{BST} = 5.0 V$, $V_{LDO1} = V_{LDO2} = 2.8 V$, $V_{LDO3} = V_{LDO4} = 1.8 V$.

Symbol	Parameter	Conditions	Min	Тур	Max	Units
EFFICIENCY				•		•
EFF _{BST}	Efficiency	PV _{IN} = 3.8 V, V _{OUT} = 5.0 V, I _{OUT} = 10 mA	88			%
		PV _{IN} = 3.8 V, V _{OUT} = 5.0 V, I _{OUT} = 600 mA	94			%
		PV _{IN} = 3.8 V, V _{OUT} = 5.0 V, I _{OUT} = 1 A	93			%
LDO1/2 SOFT STA	ART					
T _{SS_LDO12}	Startup Time	Time from enabling to 90% of V _{OUT} (2.8 V), I _{OUT} = 10 mA, C _{OUT} = 14.7 uF		100	150	μs
PSRR & NOISE	•	•		•	•	
PSRR _{L12 1KHZ}	Power Supply Rejection Ratio	$V_{IN12} = 3.4 \text{ V}, I_{OUT} = 100 \text{ mA}, \text{ F} = 1 \text{ kHz}, \text{ C}_{OUT} = 2.2 \text{ uF}, I_{BUCK} = 1.2 \text{ A}, I_{BST} = 1 \text{ A}$		70		dB
PSRR _{L12 100KHZ}		V_{IN12} = 3.4 V, I_{OUT} = 100 mA, F = 100 kHz, C_{OUT} = 2.2 uF, I_{BUCK} = 1.2 A, I_{BST} = 1 A		45		dB
V _{N_L12}	LDO1/2 Output Noise	V_{IN12} = 3.4 V, V_{OUT} = 1.8 V and 2.8 V, F = 100 Hz to 100 kHz, I_{OUT} = 100 mA, C_{OUT} = 2.2 uF		35	60	uVrms
REGULATION & T	RANSIENT PERFORMAN	CE				
REG _{L12_LD}	LDO Load Regulation	I_{OUT} = 100 uA to 300 mA, AV _{IN} = V _{IN12} = 3.8 V	-0.5		+0.5	%
REG_{L12}_{LN}	LDO Line Regulation	$AV_{IN} = V_{IN12} = 3.1$ V to 4.4 V and $AV_{IN}/V_{IN12} > V_{OUT} + 300$ mV, $I_{OUT} = 50$ mA and 300 mA			+0.5	%
V _{L12 TR_LD}	LDO Load Transient	I _{OUT} = 1 mA <-> 100 mA, 150 mA/us			±50	mV
SHORT CIRCUIT						
T _{L12 SC_DEB}	Short Circuit Debounce Timer			40		μs
T _{L12 SC_RST}	Period from Short Circuit Shutdown to Restart			20		ms
LDO3/4 SOFT STA	ART					
T _{SS_L34}	Soft Start Time	Time from enabling to 90% of V _{OUT} (1.8 V), I _{OUT} = 10 mA, C _{OUT} = 14.7 uF		80	150	μs
PSRR & NOISE	•	•		•	•	
PSRR _{L34}	Power Supply Rejection Ratio	I_{OUT} = 100 mA, F = 1 kHz, V _{IN3/4} = 1.95 V, C _{OUT} = 2.2 uF, I _{BUCK} = 1.2 A, I _{BST} = 1 A		60		dB
		I_{OUT} = 100 mA, F = 10 kHz, V _{IN3/4} = 1.95 V, C _{OUT} = 2.2 uF, I _{BUCK} = 1.2 A, I _{BST} = 1 A		45		dB
V _{N_L34}	LDO3/4 Output Noise	V _{IN3/4} = 1.95 V, V _{OUT} = 1.8 V, F = 100 Hz to 100 kHz, I _{OUT} = 100 mA, C _{OUT} = 2.2 uF		25	60	uVrms
REGULATION & T	RANSIENT PERFORMAN	CE				
REG _{L34_LD}	LDO Load Regulation	I_{OUT} = 100 uA to 300 mA, AV_{IN} = V_{IN3/4} = 3.8 V, V_{OUT} = 1.8 V	-0.5		+0.5	%
REG _{L34_LN}	LDO Line Regulation				+0.5	%
V _{L34 TR LD}	LDO Load Transient	I _{OUT} = 1 mA <-> 100 mA, 150 mA/us			±50	mV

Table 7. SYSTEM CHARACTERISTICS (continued)

System Specifications are guaranteed by design and are not production tested. They reflect closed loop performance using the Recommended Layout and External Components. Minimum and Maximum values are at $AV_{IN} = PV_{IN} = 2.5 V to 5.5 V \& PV_{IN} > V_{BUCK} + 350 mV$ and $PV_{IN} < V_{BST} - 250 mV$, $V_{IN12} = 2.5 V to 5.5 V \& V_{IN} > V_{LDO1/2} + 300 mV$, V_{IN3} , $V_{IN4} = 1.95 V to 5.5 V \& V_{IN3}$, $V_{IN4} > V_{LDO3/4} + 150 mV$, $V_{BUCK} = 0.6 V to 3.3 V$, $V_{BST} = 3.0 V to 5.7 V$, V_{LDO1} , V_{LDO2} , V_{LDO3} and $V_{LDO4} = 0.8 V to 3.3 V$, $T_A = -40^{\circ}C$ to $85^{\circ}C$, unless otherwise noted. Typical values are at $T_A = 25^{\circ}C$, $AV_{IN} = PV_{IN} = V_{IN12} = 3.8 V$, $V_{IN3} = V_{IN4} = 1.95 V$, $V_{BUCK} = 1.1 V$, $V_{BST} = 5.0 V$, $V_{LDO1} = V_{LDO2} = 2.8 V$, $V_{LDO3} = V_{LDO4} = 1.8 V$.

Symbol	Parameter	Conditions	Min	Тур	Max	Units
SHORT CIRCUIT						
T _{L34 SC_DEB}	Short Circuit Debouncer Timer			40		μs
$T_{L34 SC_RST}$	Period from Short Circuit Shutdown to Restart			20		ms
THERMAL PROT	ECTION					

T _{WRN}	Thermal Warning	115	125	135	°C
T _{SD}	Thermal Shutdown	130	140	150	°C

TYPICAL CHARACTERISTICS

Unless otherwise specified, $T_A = 25^{\circ}C$, $AV_{IN} = PV_{IN} = V_{IN12} = 3.8 \text{ V}$, $V_{IN3} = V_{IN4} = 1.95 \text{ V}$, $V_{BUCK} = 1.1 \text{ V}$, $V_{BST} = 5.0 \text{ V}$, $V_{LDO1} = V_{LDO2} = 2.8 \text{ V}$, $V_{LDO3} = V_{LDO4} = 1.8 \text{ V}$, Recommended Layout and External Components.

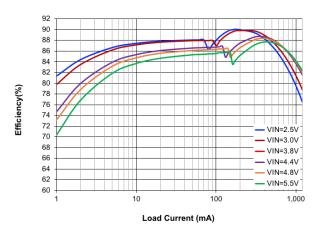
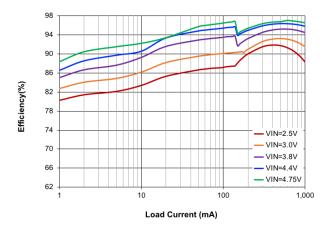
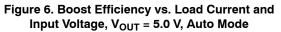
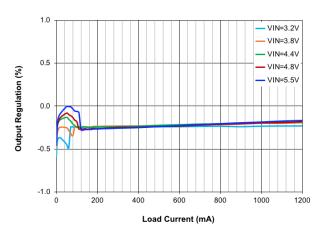
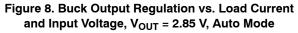


Figure 4. Buck Efficiency vs. Load Current and Input Voltage, V_{OUT} = 1.1 V, Auto Mode









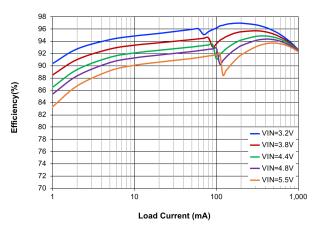
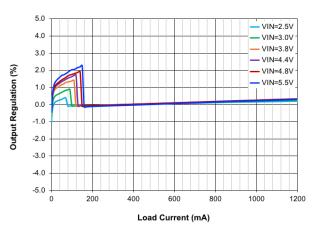


Figure 5. Buck Efficiency vs. Load Current and Input Voltage, V_{OUT} = 2.85 V, Auto Mode





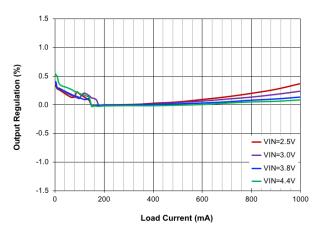


Figure 9. Boost Output Regulation vs. Load Current and Input Voltage, V_{OUT} = 5.0 V, Auto Mode

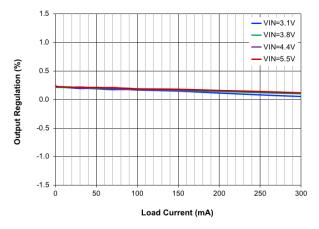


Figure 10. LDO1/2 Output Regulation vs. Load Current and Input Voltage, V_{OUT} = 2.8 V, Auto Mode

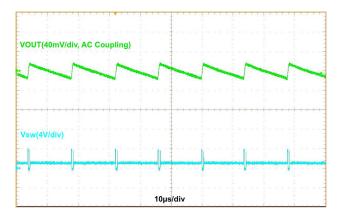
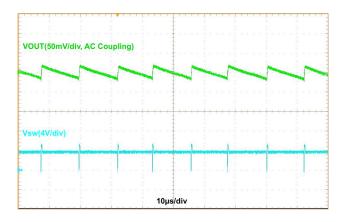
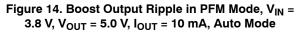


Figure 12. Buck Output Ripple in PFM Mode, V_{IN} = 3.8 V, V_{OUT} = 1.1 V, I_{OUT} = 10 mA





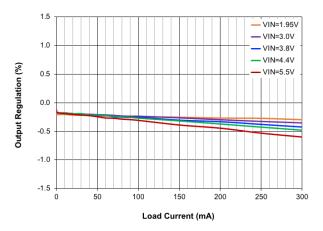


Figure 11. LDO3/4 Output Regulation vs. Load Current and Input Voltage, V_{OUT} = 1.8 V, Auto Mode

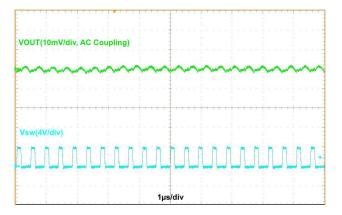


Figure 13. Buck Output Ripple in PWM Mode, V_{IN} = 3.8 V, V_{OUT} = 1.1 V, I_{OUT} = 200 mA

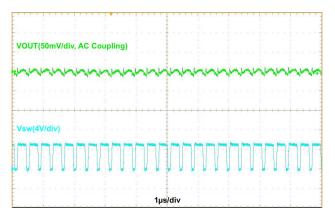


Figure 15. Boost Output Ripple in PWM Mode, $V_{IN} =$ 3.8 V, $V_{OUT} =$ 5.0 V, $I_{OUT} =$ 500 mA, Auto Mode

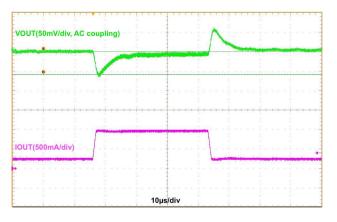


Figure 16. Buck Load Transient, V_{IN} = 3.8 V, V_{OUT} = 1.1 V, 240 mA \Leftrightarrow 960 mA, 1 μ s Edge, Auto Mode

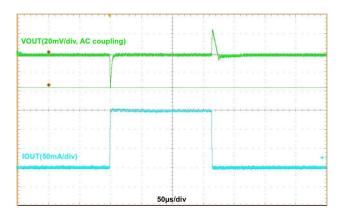
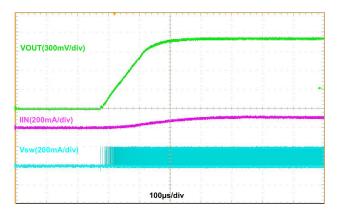
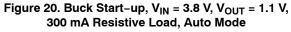


Figure 18. LDO1/2 Load Transient, V_{IN} = 3.8 V, V_{OUT} = 2.85 V, 1 mA \Leftrightarrow 150 mA, 1 µs Edge





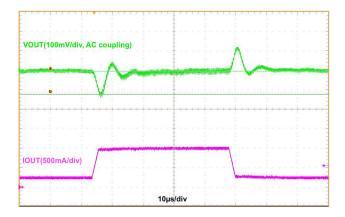


Figure 17. Boost Load Transient, V_{IN} = 3.8 V, V_{OUT} = 5.0 V, 200 mA \Leftrightarrow 800 mA, 2 µs Edge, Auto Mode

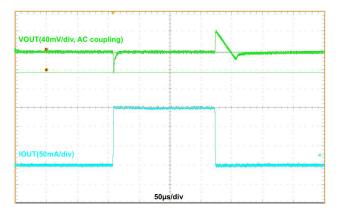


Figure 19. LDO3/4 Load Transient, V_{IN} = 1.95 V, V_{OUT} = 1.8 V, 1 mA \Leftrightarrow 150 mA, 1 μ s Edge

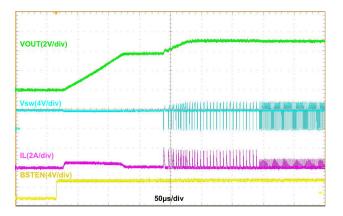


Figure 21. Boost Start–up, V_{IN} = 3.8 V, V_{OUT} = 5.0 V, 100 mA Resistive Load, Auto Mode

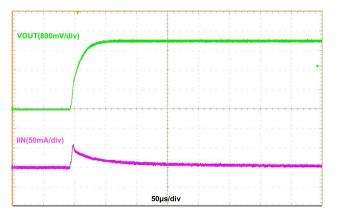
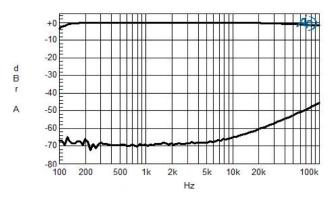
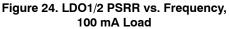
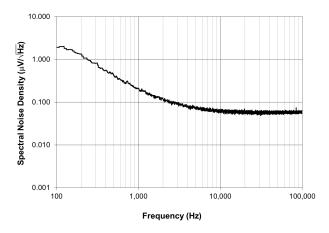
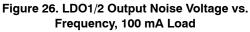


Figure 22. LDO1/2 Start–up, V_{IN} = 3.8 V, V_{OUT} = 2.8 V, No Load









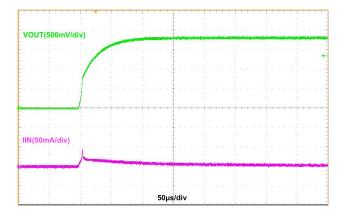


Figure 23. LDO3/4 Start–up, V_{IN} = 1.95 V, V_{OUT} = 1.8 V, No Load

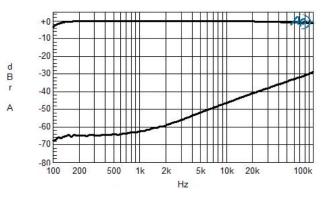
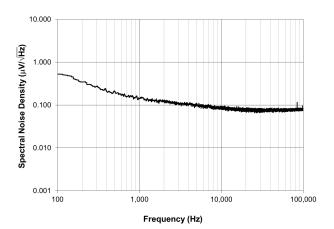
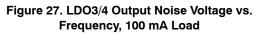


Figure 25. LDO3/4 PSRR vs. Frequency, 100 mA Load





FUNCTIONAL SPECIFICATIONS

Device Operation

Overview

The FAN53880 is a Mini-PMIC containing:

- One 2.5 MHz, 1200 mA Buck converter
- One 2.5 MHz, 1000 mA Boost converter
- Four 300 mA low noise LDOs

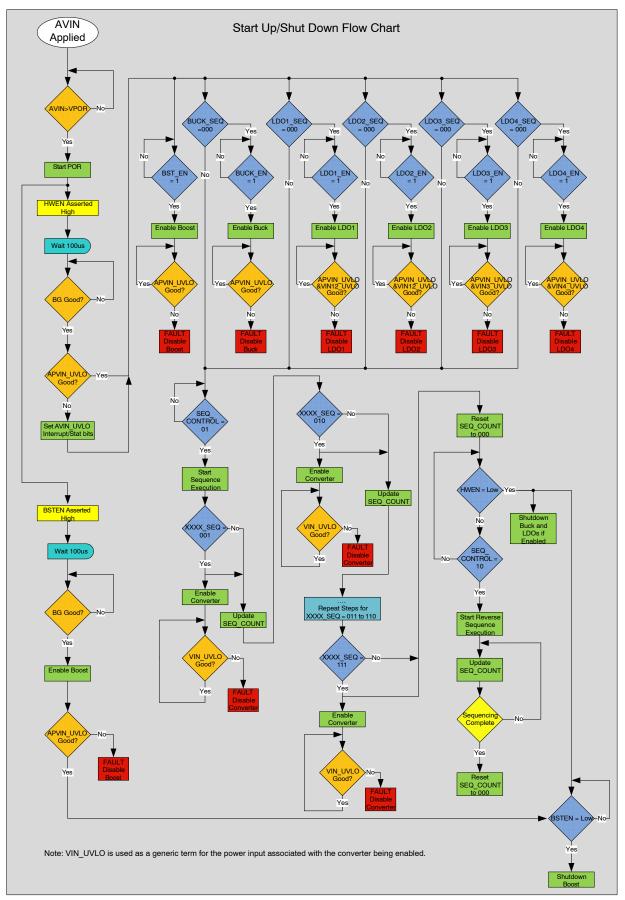
Each converter can be individually enabled/disabled through I2C communication. The Boost converter also has an enable pin, BSTEN. A configurable sequencer is

available for power-up and power-down of the Buck and LDOs.

Many of the ICs protection mechanisms have programmable thresholds. For fault handling, a dedicated interrupt pin, mask–able interrupt bits, and real time status bits are provided.

The Buck and Boost allow the use of small inductors and capacitors for a small overall solution size.

Refer to the figure below for an additional overview of the FAN53880 operation.





Power Supplies

All converters use AV_{IN} to power their analog and control circuitry.

The Buck and Boost use PV_{IN} as their power source. PV_{IN} must remain within 25 mV of AV_{IN} for proper device operation (it's recommended to locally connect PVIN to AVIN). Because of this, the term APV_{IN} may instead be used throughout this datasheet.

LDO1 and LDO2 use $V_{\rm IN12},$ LDO3 uses $V_{\rm IN3}$ and LDO4 uses $V_{\rm IN4}$ to power their outputs. These power supplies have independent UVLO thresholds with dedicated interrupts and status bits.

See Table 8 for details.

Table 8. CONVERTER DEPENDENCY OFF POWER INPUTS

Converter	AV _{IN}	PVIN	V _{IN12}	V _{IN3}	V _{IN4}
BUCK	Х	Х			
BOOST	Х	Х			
LDO1/LDO2	Х		Х		
LDO3	Х			Х	
LDO4	Х				Х

POR

When a rising AV_{IN} reaches ~2 V a POR occurs where registers reset and are readable through I2C. See Table 9 for details.

•	Table 9. PMIC OPERATION IN APVIN UV	/LO
	AV/ State	

AV _{IN} State	HWEN or BSTEN = High	Results	After AV _{IN} > UVLO
AV _{IN} < V _{POR}	No	(1)	(4)
V _{POR} <av<sub>IN < UVLO</av<sub>	No	(2)	(5)
AV _{IN} < V _{POR}	Yes	(1)	(4)
V _{POR} < AV _{IN} < UVLO	Yes	(3)	(6)

- 1. Device in shutdown, I2C registers not reliable
- 2. Band Gap off, I2C registers readable
- 3. Band Gap on, I2C registers readable
- 4. All registers set to their default values
- 5. Registers retain value prior to the fault and begin a start up after HWEN or BSTEN are high
- 6. Registers retain value prior to fault and do an automatic restart

UVLO Rising

When rising AV_{IN} reaches $V_{VIN_UVLO_RISE}$ the ICs internal circuitry is operable and an interrupt is generated. The part will be in a Sleep state if HWEN=BSTEN=LOW.

UVLO Falling

When falling AV_{IN} reaches $V_{VIN_UVLO_FALL}$ a Chip Fault occurs, all converters are suspended, an interrupt generated, and related Status bits set. Registers will not reset to default values unless AV_{IN} falls below POR (~2 V).

Control Pins and Enable Bits

There are two control pins, HWEN and BSTEN.

When HWEN=HIGH, the ICs internal circuitry turns on in Standby state where converters can be enabled through I2C, assuming their related power supplies are above their UVLO thresholds (refer to the Electrical Characteristics table).

Each converter has an independent enable bit, XXX_EN.

The BSTEN pin is a hardware enable option for the Boost and its basic control circuits. BSTEN functions independent of HWEN.

Enable Auto-Sequencing

A programmable sequencer is available for controlling power-up and power-down timing of the Buck and LDOs.

There are 7 time slots available and the sequencing speed (period per slot) is programmable. The FAN53880 sequences through time slots 001 to 111 during power up, and from 111 to 001 during power down when initiated with the SEQ_CONTROL bits.

When a converter is added into a sequence slot, it can no longer be enabled using the XXX_EN bits.

If a converter faults during a start–up sequence, the other converters will be started in their assigned time slot and the faulted converter will not attempt to re–enable. An interrupt is generated to inform the host of the fault and a status bit is set.

The two tables below summarize control pin, register bit, and sequence combinations.

Table 10. BUCK AND LDO ENABLE/DISABLE CONTROLS

	E	Buck and I	DO Control	
HWEN	XXX_SEQ	XXX_EN	SEQ_CONTROL Dependent	On/Off
Low	000	0	No	Off
High	000	0	No	Off
Low	>000	0	No	Off
High	>000	0	Yes	CNTL
Low	000	1	No	Off
High	000	1	No	On
Low	>000	1	No	Off
High	>000	1	Yes	CNTL

NOTE: CNTL indicates that the state of the output will be dependent on the setting of the SEQ_CONTROL bits. When HWEN is high, SEQ_CONTROL = 01 will enable any outputs based on their XXX_SEQ > 000.

Table 11. BOOST ENABLE/DISABLE CONTROLS

	Boost	t Control	
HWEN	BSTEN	BST_ENx	On/Off
Low	Low	0	Off
High	Low	0	Off
Low	High	0	On
High	High	0	On
Low	Low	1	Off
High	Low	1	On
Low	High	1	On
High	High	1	On

NOTE: The Boost Control table above shows that the Boost operation requires either BSTEN to be high or a combination of HWEN high and one of the enable bits in register 0x0A needs to be set to 1.

Fault Protection

Fault Protection Overview

Each fault described below has a dedicated interrupt and status bit.

The FAN53880 has two levels of fault protection:

• Chip Faults

(TSD, APV_{IN} UVLO)

The protection suspends or shuts off all enabled converters. Recovery behavior depends on the FLT_SD_B bit setting.

 Converter Faults (UVP, OVP, IPK, Short Circuit, V_{IN12}/V_{IN3}/V_{IN4} UVLO) These protections allow the converter to remain enabled or suspends or shuts off the faulted converter, but doesn't affect operation of non-related converters. The specific fault behavior depends on the FLT_SD_B bit setting.

FLT_SD_B Bit

There are two I2C selectable fault behavior options:

- Multiple Fault Shutdown (default) Limits repetitive starting and faulting of a converter or chip faults to 4 failures.
- Automatic Fault Recovery No limit to repetitive starting and faulting of a converter or to number of chip faults.
- NOTE: Sequencer fault behavior is independent of these protection schemes.

Multiple Fault Shutdown

FLT_SD_B="0" (default)

- If a fault occurs, the IC will:
- Suspend the converter
- Set Interrupt and Status bits
- Increment the internal 4-fault counter
- Wait 20 ms
- Re-enable the converter if XXX_EN="1" or shut off the converter if XXX_SEQ="1"
 - Re-enable requires another SEQ_CONTROL="01" write
- NOTE: UVLO and TSD faults will not re-enable the converter after 20 ms unless the fault was removed.

If any four Chip Faults occur, the IC will:

- Shut off all converters
- Reset all XXX_EN and XXX_SEQ bits to "0"
- Set Interrupt and Status bits, including the CHIP_SUSD Status bit, to "1". This bit will only clear after both HWEN and BSTEN are set LOW

If any four Converter Faults occur, the IC will:

- Shut off that converter
- Set XXX_SUSD bit to "1". This bit will only clear after that converter is successfully re-enabled
- Reset that converter's XXX_EN or XXX_SEQ bit to "0"

Re-enabling any converter after a fourth Chip Fault first requires setting the HWEN and BSTEN pins LOW. Any time HWEN and BSTEN pin is taken LOW, all fault counters are globally reset.

Automatic Fault Recovery

FLT_SD_B="1" (should only be set prior to enabling any converter).

If a fault occurs, the IC will:

• Set Interrupt and Status bits Also:

Chip Faults

- Suspend all converters
- Any converter with XXX_EN="1" will re-enable after the APV_{IN} UVLO or TSD fault is removed
- Any converter with XXX_SEQ="1" re-enable requires another SEQ_CONTROL="01" write

Converter Faults

- Any converter with an OVP or UVP, or any LDO with an IPK or LDO short circuit fault will remain enabled. Otherwise suspend that converter and:
 - · Automatically re–enable after $V_{IN12}/V_{IN3}/V_{IN4}$ UVLO fault is removed
 - Automatically re-enable 20 ms after Buck or Boost IPK fault or short circuit if XXX_EN="1", or remain off until another SEQ_CONTROL="01" write if XXX_SEQ="1"

Thermal Management

When the die temperature rises to T_{WRN} , a Thermal Warning (TSD_WRN) interrupt is issued. Also, a Status bit will be set and remain set until the die temperature drops to a nominal value of 110°C.

If the die temperature continues to rise above T_{WRN} , Thermal Shutdown (TSD) will occur. After the die temperature has fallen below T_{WRN} , recovery behavior depends on the FLT_SD_B bit setting. Refer to the Fault Protection section for details on Chip Faults.

Fault Handling

Mask-able Interrupt bits, a dedicated INTB pin, and real time status bits are provided. Each converter has independent protection debounce timers.

An interrupt is generated each time a fault occurs. All bits set in the Interrupt registers must be cleared to reset the INTB pin to HIGH.

Buck Functionality

Startup Behavior

The Buck can be enabled by two methods if and only if the HWEN pin is high:

- Setting BUCK_EN to "1"
- Setting BUCK_SEQ > "000" and SEQ_CONTROL to "01"

The Buck has internal soft–start and starts up within $400 \ \mu s$ (typical) when using the recommended external components.

Modes of Operation

During PWM operation, the Buck switches at a nominal fixed frequency of 2.5 MHz. In Automode at light load operation, the device will enter PFM mode. Instead, the Buck can be put into Forced PWM mode by setting the BUCK_MODE bit to "1". Also, the FAN53880 provides a bit, BUCK_LOAD, which the user can set to apply an internal artificial load to maintain a minimum switching frequency above 20 kHz.

Programmable Output Voltage

The Buck output voltage can be programmed via I2C in 12.5 mV steps.

Shutdown

When the Buck is disabled, switching will cease, the output tristated, and the output will be discharged via the load or if BUCK_DIS bit = "1", via the active discharge resistor.

Boost Functionality

Startup Behavior

The Boost can be enabled by two methods:

- Setting the BSTEN pin HIGH
- Setting the HWEN pin HIGH and setting any BOOST_ENx bit to "1"

The Boost can startup in PFM mode or automatic pass-through mode depending on the VIN to VOUT difference. When starting in PFM mode, the part has a linear mode which limits inrush currents. Once VOUT charges up to VIN, the linear mode current limit is disabled and the regulator uses one-quarter current limit to charge the output cap to the final VOUT target value. If VOUT fails to reach 90% of the VOUT target within 1 ms, a UVP fault is declared.

Modes of Operation

During PWM operation, the Boost switches at a nominal fixed frequency of 2.5 MHz. In Automode at light load operation, the device will enter PFM mode. Instead, the Boost can be put into Forced PWM mode by setting the BST_MODE bit to "1". Also, the FAN53880 provides a bit, BST_LOAD, which the user can set to apply an internal artificial load to maintain a minimum switching frequency above 20 kHz.

In normal operation, the device automatically transitions from Boost Mode to Pass–Through Mode if

 $V_{IN} > V_{OUT}$ _target – 250 mV. In Pass–Through Mode, there is no switching and the device has a low impedance path between V_{IN} and V_{OUT} .

Programmable Output Voltage

The Boost output voltage can be programmed via I2C in 25 mV steps. When the output voltage is programmed to a lower voltage, the active pull-down is used to expedite the drop in voltage across the output capacitance.

Shutdown

When the Boost is disabled, switching will cease, the output tristated, and the output will be discharged via the load or if BOOST_DIS bit = "1", via the active discharge resistor.

LDO Functionality

Startup Behavior

The LDO's can be enabled by two methods if and only if the HWEN pin is high:

- Setting LDOx_EN to "1"
- Setting LDO_SEQ > "000" and SEQ_CONTROL to "01"

The Buck has internal soft-start which limits supply current to the LDOx_ILIM setting. If VOUT fails to reach UVP_{LDOxx_HYS} in T_{SS_LDOxx} , a UVP fault is declared.

Programmable Output Voltage

The LDO output voltages can be programmed via I2C in 25 mV steps.

I2C Functionality

Introduction

The FAN53880 serial interface is compatible with the Standard–Mode, Fast–Mode, and Fast–Mode Plus I^2C bus

specifications. The SCL pin is an input and the SDA pin is a bi-directional open-drain output. The IC supports single register read and write transactions as well as multiple register read transactions.

Slave Address

The default I2C Slave Address is the Table 12 and Table 13. Other slave addresses can be accommodated upon request. Contact your ON Semiconductor representative if a different slave address is required.

Table 12. I2C SLAVE ADDRESS

Device	Hex	Decimal	7 bit Binary
FAN53880	7h35	53d	0110101

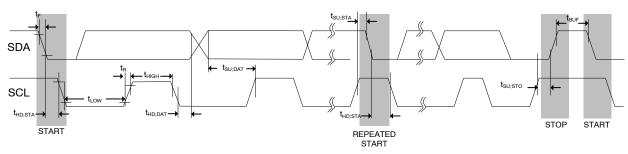
Table 13. FAN53880 (7 BIT) SLAVE ADDRESS BYTE

7	6	5	4	3	2	1	Х
0	1	1	0	1	0	1	R/W

NOTE: READ = 1

WRITE = 0

Timing Diagrams





Normally, data transfer occurs when SCL is LOW. Data is clocked in on the rising edge of SCL. Typically data transitions at or after the subsequent falling edge of SCL to provide ample setup time for the next data bit to be ready before the subsequent rising edge of SCL.

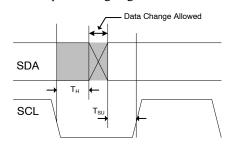


Figure 30. Data Transfer Timing

The idle state of the I^2C bus is SDA and SCL both in the HIGH state. A valid transaction begins with a START condition which occurs when SDA transitions from HIGH to LOW when SCL remains HIGH.

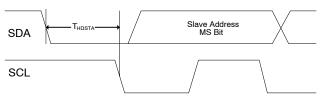


Figure 31. START Condition

A valid transaction ends with a STOP condition which occurs when SDA transitions from LOW to HIGH while SCL remains HIGH.

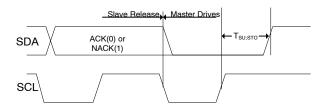


Figure 32. STOP Condition

A REPEATED START condition is functionally equivalent to a STOP condition followed immediately by a START condition. During a read from the IC, the master issues a REPEATED START after sending the register address and before re-sending the slave address. The REPEATED START is a HIGH to LOW transition on SDA while SCL is HIGH,

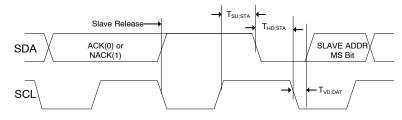


Figure 33. REPEATED START Condition

Read and Write Transactions

The FAN53880 supports the following read and write transaction protocols.

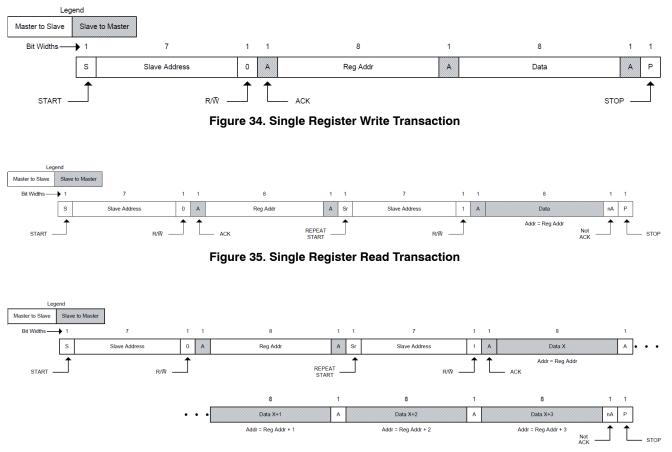


Figure 36. Multiple Register Read Transaction

REGISTER MAPPING TABLE

Table 14. REGISTER MAPPING

					Read Only	Write Only	Read / Write	Read / Clear	Write / Clear			
Address	Name	Bit[7]	Bit[6]	Bit[5]	Bit[4]	Bit[3]	Bit[2]	Bit[1]	Bit[0]			
0x00	PROD- UCT ID	Product ID						•	•			
0x01	SILICON REV ID	Revision	Revision									
0x02	BUCK	BUCK_OUT										
0x03	BOOST	Reserved	BOOST_VO	UT								
0x04	LDO1	LDO1_PA- SSTHRU	LDO1_VOUT	Г								
0x05	LDO2	LDO2_PA- SSTHRU	LDO2_VOUT	г								
0x06	LDO3	LDO3_PA- SSTHRU	LDO3_VOUT	г								
0x07	LDO4	LDO4_PA- SSTHRU	LDO4_VOUT	г								
0x08	IOUT	0	LDO4_ILIM	0	LDO3_ILIM	0	LDO2_ILIM	0	LDO1_IL- IM			
0x09	ENABLE	BST_MOD- E	BUCK_MO- DE	0	BUCK_EN	LDO4_EN	LDO3_EN	LDO2_EN	LDO1_EN			
0x0A	BOOST_E- NABLE	BST_EN7	BST_EN6	BST_EN5	BST_EN4	BST_EN3	BST_EN2	BST_EN1	BST_EN0			
0x0B	BUCK_SE- Q			0			BUCK_SEQ					
0x0C	LDO12_S- EQ	()	LDO2_SEQ			LDO1_SEQ					
0x0D	LDO34_S- EQ	()	LDO4_SEQ			LDO3 SEQ					
0x0E	SE- QUENC- ING	SEQ_SPEE	D	SEQ_CONTR	OL	SEQ_ON	SEQ_COUNT	r				
0x0F	DIS- CHARGE	BUCK_LO- AD	BOOST_L- OAD	LDO4_DIS	LDO3_DIS	LDO2_DIS	LDO1_DIS	BOOST_D- IS	BUCK_DIS			
0x10	RESET	0	SOFT_RESE	ĒT	•	•	0	1	FLT_SD_B			
0x11	INTER- RUPT1	LDO4_OV- P_INT	LDO3_OV- P_INT	LDO2_OVP _INT	LDO1_OVP _INT	LDO4_UVP _INT	LDO3_UVP _INT	LDO2_UV- P_INT	LDO1_UV- P_INT			
0x12	INTER- RUPT2	BST_OVP _INT	BUCK_OV- P_INT	BST_UVP_I- NT	BUCK_UVP _INT	LDO4_OCP _INT	LDO3_OCP _INT	LDO2_OC- P_INT	LDO1_OC- P_INT			
0x13	INTER- RUPT3	BST_IPK_I- NT	BUCK_IPK _INT	APVIN_UVL- O_INT	LDO12_UVL- O_INT	LDO3_UVL- O_INT	LDO4_UVL- O_INT	TSD_INT	TSD_WRN _INT			
0x14	STATUS1	LDO4_OV- P_STAT	LDO3_OV- P_STAT	DO3_OV-LDO2_OVP _STATSTAT		LDO4_UVP _STAT	LDO3_UVP _STAT	LDO2_UV- P_STAT	LDO1_UV- P_STAT			
0x15	STATUS2	BST_OVP _STAT	BUCK_OV- P_STAT	BST_UVP STAT	BUCK_UVP _STAT	LDO4_OCP _STAT	LDO3_OCP _STAT	LDO2_OC- P_STAT	LDO1_OC- P_STAT			
0x16	STATUS3	BST_IPK STAT	BUCK_IPK _STAT	APVIN_UVL- O_STAT	LDO12_UVL- O_STAT	LDO3_UVL- O_STAT	LDO4_UVL- O_STAT	TSD_STAT	TSD_WRN _STAT			

Table 14. REGISTER MAPPING

					Read Only	Write Only	Read / Write	Read / Clear	Write / Clear
Address	Name	Bit[7]	Bit[6]	Bit[5]	Bit[4]	Bit[3]	Bit[2]	Bit[1]	Bit[0]
0x17	MINT1	MASK_LD- O4_OVP	MASK_LD- O3_OVP	MASK_LDO 2_OVP	MASK_LDO 1_OVP	MASK_LDO 4_UVP	MASK_LDO 3_UVP	MASK_LD- O2_UVP	MASK_LD- 01_UVP
0x18	MINT2	MASK_BS- T_OVP	MASK_BU- CK_OVP	MASK_BST _UVP	MASK_BUC- K_UVP	MASK_LDO 4_OCP	MASK_LDO 3_OCP	MASK_LD- 02_OCP	MASK_LD- 01_OCP
0x19	MINT3	MASK_BS- T_IPK	MASK_BU- CK_IPK	MASK_APVI- N_UVLO	MASK_LDO 12_UVLO	MASK_LDO 3_UVLO	MASK_LDO 4_UVLO	MASK_TS- D	MASK_TS- D_WRN
0x1A	STATUS4	0	CHIP_SUS- D	BOOST_SU- SD	BUCK_SUS- D	LDO4_SUS- D	LDO3_SUS- D	LDO2_SU- SD	LDO1_SU- SD

REGISTER DETAILS

Table 15. REGISTER DETAILS - 0x00 PRODUCT ID

	0x00 PRC	DUCT ID		Default =	: 00000001
Bit	Name	Default	Туре	Desc	ription
7:00	Product ID	0000001	Read	Allows customers to identi	fy manufacturer and version
				Produc	t ID Table
				Code	Product
				0	-
				1	FAN53880
				10	Reserved
				11	Reserved
				100	Reserved
				101	Reserved
				110	Reserved
				111	Reserved
				1000	Reserved
				1001	Reserved
				1010	Reserved
				1011	Reserved
				1100	Reserved
				1101	Reserved
				1110	Reserved
				1111	Reserved

Table 16. REGISTER DETAILS – 0x01 SILICON REV ID

	0x01 SILIC	ON REV ID		Default = See Description		
Bit	Name	Default	Туре	Description		
7:0	Revision	See	Read	ad Provides the silicon revision		
		Description	Part Number	REG 01 [7:0] Silicon Rev ID		
				FAN53880UC001X	00000011	
				FAN53880UC002X	00000100	

Table 17. REGISTER DETAILS - 0x02 BUCK

	0x02 E	BUCK			Default =	0000000	
Bit	Name	Default	Туре		Descr	ription	
7:00	BUCK_OUT	0000000	R/W	Buck program Vout = [0.0125	ming steps are 12. x (d–31)] + 0.6; W regis	here "d" is the dec	e of 0.6 to 3.3 V. simal value of the
				Hex	V _{OUT}	Hex	V _{OUT}
				0	DEFAULT	28	0.7125V
				01 –1E	Reserved	29-F6	
				1F	0.6000V	F0	3.2125V
				20	0.6125V	F1	3.2250V
				21	0.6250V	F2	3.2375V
				22	0.6375V	F3	3.2500V
				23	0.6500V	F4	3.2625V
				24	0.6625V	F5	3.2750V
				25	0.6750V	F6	3.2875V
				26	0.6875V	F7	3.3000V
				27	0.7000V	F8-FF	Reserved

Table 18. REGISTER DETAILS - 0x03 BOOST

	0x03 BC	OST					Default =	0000000	I			
Bit	Name	Default	Туре		Description							
7	BST_PASS	0	R/W									
6:0	BOOST_VO UT	0000000	R/W		The boos Equation: V _{OI}	t output v _{JT} = 3.00	oltage is prog 0 + (d–4)*0.0	grammable 25V; wher	e in the 25 m e "d" is the c	nV steps. lecimal va	ue.	
				Hex	V _{OUT}	Hex	V _{OUT}	Hex	V _{OUT}	Hex	V _{OUT}	
				0	DEFAULT	20	3.700V	40	4.500V	60	5.300V	
				1	Reserved	21	3.725V	41	4.525V	61	5.325V	
				2	Reserved	22	3.750V	42	4.550V	62	5.350V	
				3	Reserved	23	3.775V	43	4.575V	63	5.375V	
				4	3.000V	24	3.800V	44	4.600V	64	5.400V	
				5	3.025V	25	3.825V	45	4.625V	65	5.425V	
				6	3.050V	26	3.850V	46	4.650V	66	5.450V	
				7	3.075V	27	3.875V	47	4.675V	67	5.475V	
				8	3.100V	28	3.900V	48	4.700V	68	5.500V	
				9	3.125V	29	3.925V	49	4.725V	69	5.525V	
				0A	3.150V	2A	3.950V	4A	4.750V	6A	5.550V	
				0B	3.175V	2B	3.975V	4B	4.775V	6B	5.575V	
				0C	3.200V	2C	4.000V	4C	4.800V	6C	5.600V	
				0D	3.225V	2D	4.025V	4D	4.825V	6D	5.625V	
				0E	3.250V	2E	4.050V	4E	4.850V	6E	5.650V	
				0F	3.275V	2F	4.075V	4F	4.875V	6F	5.675V	
				10	3.300V	30	4.100V	50	4.900V	70	5.700V	
				11	3.325V	31	4.125V	51	4.925V	71–7F	Reserved	
				12	3.350V	32	4.150V	52	4.950V		•	
				13	3.375V	33	4.175V	53	4.975V			
				14	3.400V	34	4.200V	54	5.000V			
				15	3.425V	35	4.225V	55	5.025V			
				16	3.450V	36	4.250V	56	5.050V			
				17	3.475V	37	4.275V	57	5.075V			
				18	3.500V	38	4.300V	58	5.100V			
				19	3.525V	39	4.325V	59	5.125V			
				1A	3.550V	ЗA	4.350V	5A	5.150V			
				1B	3.575V	3B	4.375V	5B	5.175V			
				1C	3.600V	ЗC	4.400V	5C	5.200V			
				1D	3.625V	3D	4.425V	5D	5.225V			
				1E	3.650V	3E	4.450V	5E	5.250V			
				1F	3.675V	3F	4.475V	5F	5.275V			

Table 19. REGISTER DETAILS - 0x04 LDO1

	0x04 L	וטע.		Default = 0000000					
Bit	Name	Default	Туре	Description					
6:0	LDO1_VOUT	0000000	R/W		Sets LDO1 regulat	ion target voltage).		
				Equation: Vo	ut = 0.800V + [(d–15 value of th)*25mV]; Where e register	d is the decima		
				Hex	V _{OUT}	Hex	V _{OUT}		
				0	DEFAULT	40	2.025V		
				1	Reserved	41	2.050V		
				2	Reserved	42	2.075V		
				3	Reserved	43	2.100V		
				4	Reserved	44	2.125V		
				5	Reserved	45	2.150V		
				6	Reserved	46	2.175V		
				7	Reserved	47	2.200V		
				8	Reserved	48	2.225V		
				9	Reserved	49	2.250V		
				0A	Reserved	4A	2.275V		
				0B	Reserved	4B	2.300V		
				0C	Reserved	4C	2.325V		
				0D	Reserved	4D	2.350V		
				0E	Reserved	4E	2.375V		
				0F	0.800V	4F	2.400V		
				10	0.825V	50	2.425V		
				11	0.850V	51	2.450V		
				12	0.875V	52	2.475V		
				13	0.900V	53	2.500V		
				14	0.925V	54	2.525V		
				15	0.950V	55	2.550V		
				16	0.975V	56	2.575V		
				17	1.000V	57	2.600V		
				18	1.025V	58	2.625V		
				19	1.050V	59	2.650V		
				1A	1.075V	5A	2.675V		
				1B	1.100V	5B	2.700V		
				1C	1.125V	5C	2.725V		
				1D	1.150V	5D	2.750V		
				1E	1.175V	5E	2.775V		
				1F	1.200V	5F	2.800V		
				20	1.225V	60	2.825V		
				21	1.250V	61	2.850V		
				22	1.275V	62	2.875V		
				23	1.300V	63	2.900V		
				24	1.325V	64	2.925V		

Table 19. REGISTER DETAILS - 0x04 LDO1

	0x04 LDO1			Default = 0000000				
Bit	Name Default Type			Description				
				25	1.350V	65	2.950V	
				26	1.375V	66	2.975V	
				27	1.400V	67	3.000V	
				28	1.425V	68	3.025V	
				29	1.450V	69	3.050V	
				2A	1.475V	6A	3.075V	
				2B	1.500V	6B	3.100V	
				2C	1.525V	6C	3.125V	
				2D	1.550V	6D	3.150V	
				2E	1.575V	6E	3.175V	
				2F	1.600V	6F	3.200V	
				30	1.625V	70	3.225V	
				31	1.650V	71	3.250V	
				32	1.675V	72	3.275V	
				33	1.700V	73	3.300V	
				34	1.725V	74	Reserved	
				35	1.750V	75	Reserved	
				36	1.775V	76	Reserved	
				37	1.800V	77	Reserved	
				38	1.825V	78	Reserved	
				39	1.850V	79	Reserved	
				ЗA	1.875V	7A	Reserved	
				3B	1.900V	7B	Reserved	
				3C	1.925V	7C	Reserved	
				3D	1.950V	7D	Reserved	
				3E	1.975V	7E	Reserved	
				3F	2.000V	7F	Reserved	

Table 20. REGISTER DETAILS - 0x05 LDO2

	0x05	_DO2		Default = 0000000				
Bit	Name	Default	Туре	Description				
7	UNUSED							
6:0	LDO2_VOUT	0000000	R/W	Sets LDO2 regulation target voltage.				
				Equation: Vol	ut = 0.800V + [(d-15) value of the)*25mV]; Where e register	d is the decimal	
				Hex	V _{OUT}	Hex	V _{OUT}	
				0	DEFAULT	40	2.025V	
				1	Reserved	41	2.050V	
				2	Reserved	42	2.075V	
				3	Reserved	43	2.100V	
				4	Reserved	44	2.125V	
				5	Reserved	45	2.150V	
				6	Reserved	46	2.175V	
				7	Reserved	47	2.200V	
				8	Reserved	48	2.225V	
				9	Reserved	49	2.250V	
				0A	Reserved	4A	2.275V	
				0B	Reserved	4B	2.300V	
				0C	Reserved	4C	2.325V	
				0D	Reserved	4D	2.350V	
				0E	Reserved	4E	2.375V	
				0F	0.800V	4F	2.400V	
				10	0.825V	50	2.425V	
				11	0.850V	51	2.450V	
				12	0.875V	52	2.475V	
				13	0.900V	53	2.500V	
				14	0.925V	54	2.525V	
				15	0.950V	55	2.550V	
				16	0.975V	56	2.575V	
				17	1.000V	57	2.600V	
				18	1.025V	58	2.625V	
				19	1.050V	59	2.650V	
				1A	1.075V	5A	2.675V	
				1B	1.100V	5B	2.700V	
				1C	1.125V	5C	2.725V	
				1D	1.150V	5D	2.750V	
				1E	1.175V	5E	2.75V	
				1F	1.200V	5F	2.800V	
				20	1.225V	60	2.825V	
				21	1.250V	61	2.850V	
				22	1.275V	62	2.875V	
				23	1.300V	63	2.900V	

Table 20. REGISTER DETAILS - 0x05 LDO2

	0x05 LDO2			Default = 00000000				
Bit	Name Default Type			Description				
				24	1.325V	64	2.925V	
				25	1.350V	65	2.950V	
				26	1.375V	66	2.975V	
				27	1.400V	67	3.000V	
				28	1.425V	68	3.025V	
				29	1.450V	69	3.050V	
				2A	1.475V	6A	3.075V	
				2B	1.500V	6B	3.100V	
				2C	1.525V	6C	3.125V	
				2D	1.550V	6D	3.150V	
				2E	1.575V	6E	3.175V	
				2F	1.600V	6F	3.200V	
				30	1.625V	70	3.225V	
				31	1.650V	71	3.250V	
				32	1.675V	72	3.275V	
				33	1.700V	73	3.300V	
				34	1.725V	74	Reserved	
				35	1.750V	75	Reserved	
				36	1.775V	76	Reserved	
				37	1.800V	77	Reserved	
				38	1.825V	78	Reserved	
				39	1.850V	79	Reserved	
				ЗA	1.875V	7A	Reserved	
				3B	1.900V	7B	Reserved	
				ЗC	1.925V	7C	Reserved	
				3D	1.950V	7D	Reserved	
				3E	1.975V	7E	Reserved	
				ЗF	2.000V	7F	Reserved	

Table 21. REGISTER DETAILS - 0x06 LDO3

	0x06	_DO3		Default = 0000000					
Bit	Bit Name Default Type				Description				
7	UNUSED								
6:0	LDO3_VOUT	0000000	R/W	Sets LDO3 regulation target voltage.					
				Equation: Vol	ut = 0.800V + [(d-15 value of th)*25mV]; Where le register	d is the decima		
				Hex	V _{OUT}	Hex	V _{OUT}		
				0	DEFAULT	40	2.025V		
				1	Reserved	41	2.050V		
				2	Reserved	42	2.075V		
				3	Reserved	43	2.100V		
				4	Reserved	44	2.125V		
				5	Reserved	45	2.150V		
				6	Reserved	46	2.175V		
				7	Reserved	47	2.200V		
				8	Reserved	48	2.225V		
				9	Reserved	49	2.250V		
				0A	Reserved	4A	2.275V		
				0B	Reserved	4B	2.300V		
				0C	Reserved	4C	2.325V		
				0D	Reserved	4D	2.350V		
				0E	Reserved	4E	2.375V		
				0F	0.800V	4F	2.400V		
				10	0.825V	50	2.425V		
				11	0.850V	51	2.450V		
				12	0.875V	52	2.475V		
				13	0.900V	53	2.500V		
				14	0.925V	54	2.525V		
				15	0.950V	55	2.550V		
				16	0.975V	56	2.575V		
				17	1.000V	57	2.600V		
				18	1.025V	58	2.625V		
				19	1.050V	59	2.650V		
				1A	1.075V	5A	2.675V		
				1B	1.100V	5B	2.700V		
				1C	1.125V	5C	2.725V		
				1D	1.150V	5D	2.750V		
				1E	1.175V	5E	2.75V		
				1F	1.200V	5F	2.800V		
				20	1.225V	60	2.825V		
				21	1.250V	61	2.850V		
				22	1.275V	62	2.875V		
				23	1.300V	63	2.900V		

Table 21. REGISTER DETAILS - 0x06 LDO3

	0x06 LDO3			Default = 00000000				
Bit	Name Default Type			Description				
				24	1.325V	64	2.925V	
				25	1.350V	65	2.950V	
				26	1.375V	66	2.975V	
				27	1.400V	67	3.000V	
				28	1.425V	68	3.025V	
				29	1.450V	69	3.050V	
				2A	1.475V	6A	3.075V	
				2B	1.500V	6B	3.100V	
				2C	1.525V	6C	3.125V	
				2D	1.550V	6D	3.150V	
				2E	1.575V	6E	3.175V	
				2F	1.600V	6F	3.200V	
				30	1.625V	70	3.225V	
				31	1.650V	71	3.250V	
				32	1.675V	72	3.275V	
				33	1.700V	73	3.300V	
				34	1.725V	74	Reserved	
				35	1.750V	75	Reserved	
				36	1.775V	76	Reserved	
				37	1.800V	77	Reserved	
				38	1.825V	78	Reserved	
				39	1.850V	79	Reserved	
				ЗA	1.875V	7A	Reserved	
				ЗB	1.900V	7B	Reserved	
				зC	1.925V	7C	Reserved	
				3D	1.950V	7D	Reserved	
				3E	1.975V	7E	Reserved	
				ЗF	2.000V	7F	Reserved	

Table 22. REGISTER DETAILS – 0x07 LDO4

	0x07	LDO4		Default = 0000000						
Bit	Name	Default	Туре	Description						
7	UNUSED									
6:0	LDO4_VOUT	0000000	R/W	Sets LDO4 regulation target voltage.						
				Equation: Vout = 0.800V + [(d-15)*25mV]; Where d is the decimal value of the register						
				Hex	V _{OUT}	Hex	V _{OUT}			
				0	DEFAULT	40	2.025V			
				1	Reserved	41	2.050V			
				2	Reserved	42	2.075V			
				3	Reserved	43	2.100V			
				4	Reserved	44	2.125V			
				5	Reserved	45	2.150V			
				6	Reserved	46	2.175V			
				7	Reserved	47	2.200V			
				8	Reserved	48	2.225V			
				9	Reserved	49	2.250V			
				0A	Reserved	4A	2.275V			
				0B	Reserved	4B	2.300V			
				0C	Reserved	4C	2.325V			
				0D	Reserved	4D	2.350V			
				0E	Reserved	4E	2.375V			
				0F	0.800V	4F	2.400V			
						10	0.825V	50	2.425V	
				11	0.850V	51	2.450V			
							12	0.875V	52	2.475V
							13	0.900V	53	2.500V
					14	0.925V	54	2.525V		
				15	0.950V	55	2.550V			
				16	0.975V	56	2.575V			
				17	1.000V	57	2.600V			
				18	1.025V	58	2.625V			
				19	1.050V	59	2.650V			
				1A	1.075V	5A	2.675V			
				1B	1.100V	5B	2.700V			
				1C	1.125V	5C	2.725V			
				1D	1.150V	5D	2.750V			
				1E	1.175V	5E	2.75V			
				1F	1.200V	5F	2.800V			
				20	1.225V	60	2.825V			
				21	1.250V	61	2.850V			
				22	1.275V	62	2.875V			
				23	1.300V	63	2.900V			

Table 22. REGISTER DETAILS – 0x07 LDO4

	0x07	LDO4		Default = 0000000				
Bit	Name	Default	Туре	Description				
				24	1.325V	64	2.925V	
				25	1.350V	65	2.950V	
				26	1.375V	66	2.975V	
				27	1.400V	67	3.000V	
				28	1.425V	68	3.025V	
				29	1.450V	69	3.050V	
				2A	1.475V	6A	3.075V	
				2B	1.500V	6B	3.100V	
				2C	1.525V	6C	3.125V	
				2D	1.550V	6D	3.150V	
				2E	1.575V	6E	3.175V	
				2F	1.600V	6F	3.200V	
				30	1.625V	70	3.225V	
				31	1.650V	71	3.250V	
				32	1.675V	72	3.275V	
				33	1.700V	73	3.300V	
				34	1.725V	74	Reserved	
				35	1.750V	75	Reserved	
				36	1.775V	76	Reserved	
				37	1.800V	77	Reserved	
				38	1.825V	78	Reserved	
				39	1.850V	79	Reserved	
				ЗA	1.875V	7A	Reserved	
				ЗB	1.900V	7B	Reserved	
				ЗC	1.925V	7C	Reserved	
				3D	1.950V	7D	Reserved	
				3E	1.975V	7E	Reserved	
				ЗF	2.000V	7F	Reserved	

Table 23. REGISTER DETAILS – 0x08 IOUT

	0x08	OUT		Defau	lt = 01010101
Bit	Name	Default	Туре	De	escription
7	UNUSED				
6	LDO4_ILIM 1 R/W	Reset	t condition: –		
				Code	Current Limit
				0	150 mA (minimum)
				1	360 mA (minimum)
5	UNUSED				
4	LDO3_ILIM	1	R/W	Code	Current Limit
				0	150 mA (minimum)
				1	360 mA (minimum)
3	UNUSED				
2	LDO2_ILIM	1	R/W	Code	Current Limit
				0	150 mA (minimum)
				1	360 mA (minimum)
1	UNUSED				L
0	LDO1_ILIM	1	R/W	Code	Current Limit
				0	150 mA (minimum)
				1	360 mA (minimum)

Table 24. REGISTER DETAILS – 0x09 ENABLE

	0x09 EN	NABLE		Default =	= 0000000	
Bit	Name	Default	Туре	Desc	ription	
7	BST_MODE	0	R/W	Code	Effect	
				0	Automatically select between PFM and PWM Modes	
				1	Forced PWM mode.	
6	BUCK_MODE	0	R/W	Code	Effect	
				0	Auto selection between PFM and PWM modes	
				1	Forced PWM mode	
5	UNUSED					
4	BUCK_EN	0	0 R/W	Enable bit for the BUCK. This bit only controls the state of the B if BUCK_SEQ = 000.		
				Code	Status of Buck	
				0	Disabled	
				1	Enabled	
3	LDO4_EN	0	R/W	Enable bit for LDO4. This bit or LDO4_S	ly controls the state of the LDO if $EQ = 000$.	
				Code	Status of LDO4	
				0	Disabled	
				1	Enabled	

Table 24. REGISTER DETAILS - 0x09 ENABLE

	0x09 El	NABLE		Default =	0000000		
Bit	Name	Default	Туре	Description			
2	LDO3_EN	DO3_EN 0		Enable bit for LDO3. This bit only controls the state of the LDO it LDO3_SEQ = 000.			
				Code	Status of LDO3		
				0	Disabled		
				1	Enabled		
1	LDO2_EN	0	R/W	Enable bit for LDO2. This bit on LDO2_S	ly controls the state of the LDO if $EQ = 000$.		
				Code	Status of LDO2		
						0	Disabled
				1	Enabled		
0	LDO1_EN	0	R/W		ly controls the state of the LDO if $EQ = 000$.		
				Code	Status of LDO1		
				0	Disabled		
				1	Enabled		

Table 25. REGISTER DETAILS – 0x0A BOOST_ENABLE

	0x0A BOOS	T_ENABLE		Default =	= 0000000	
Bit	Name	Default	Туре	Desc	ription	
7	BST_EN7	BST_EN7 0	BST_EN7 0 R/W	R/W	BST_EN7 bit is for ena	bling the boost converter.
				Code	Effect	
				0	Disabled	
				1	Enabled	
6	BST_EN6	0	R/W	BST_EN6 bit is for ena	bling the boost converter.	
				Code	Effect	
				0	Disabled	
				1	Enabled	
5	BST_EN5 0	D R/W	BST_EN5 bit is for ena	bling the boost converter.		
				Code	Effect	
				0	0	Disabled
				1	Enabled	
4	BST_EN4	0	R/W	BST_EN4 bit is for ena	bling the boost converter.	
				Code	Effect	
				0	Disabled	
				1	Enabled	
3	3 BST_EN3 0	R/W	BST_EN3 bit is for ena	bling the boost converter.		
				Code	Effect	
				0	Diabled	
				1	Enabled	

Table 25. REGISTER DETAILS – 0x0A BOOST_ENABLE

	0x0A BOOS	T_ENABLE		Default =	= 0000000
Bit	Name	Default	Туре	Desc	ription
2	BST_EN2	0	R/W	BST_EN2 bit is for ena	bling the boost converter.
				Code	Effect
				0	Disabled
				1	Enabled
1	BST_EN1	0	R/W	BST_EN1 bit is for ena	bling the boost converter.
				Code	Effect
				0	Disabled
				1	Enabled
0	BST_EN0	0	R/W	BST_EN0 bit is for ena	bling the boost converter.
				Code	Effect
				0	Disabled
				1	Ensabled

Table 26. REGISTER DETAILS – 0x0B BUCK_SEQ

	0x0B BU	CK_SEQ		Det	fault = 00000000
Bit	Name	Default	Туре		Description
7:3	UNUSED				
2:0	BUCK_SEQ	000	R/W	The buck sequenci	ng is selected by setting bits [2:0]
			Γ	Code	Effect
				000	Controlled through I2C by setting the buck_en bit.
				001	Selects slot 1 for the buck to be enabled in at power up.
				010	Selects slot 2 for the buck to be enabled in at power up.
				011	Selects slot 3 for the buck to be enabled in at power up.
				100	Selects slot 4 for the buck to be enabled in at power up.
				101	Selects slot 5 for the buck to be enabled in at power up.
				110	Selects slot 6 for the buck to be enabled in at power up.
				111	Selects slot 7 for the buck to be enabled in at power up.

Table 27. REGISTER DETAILS - 0x0C LDO12_SEQ

	0x0C LDC	012_SEQ		Default = 00000000																																									
Bit	Name	Default	Туре		Description																																								
7:6	UNUSED																																												
5:3	LDO2_SEQ	000	R/W	The LDO2 sequenci	ng is selected by setting bits [2:0]																																								
				Code	Effect																																								
			-	000	Controlled through I2C by setting the LDO2_EN bit.																																								
			-	001	Selects slot 1 for the LDO2 to be enabled in at power up.																																								
			-	010	Selects slot 2 for the LDO2 to be enabled in at power up.																																								
			-	011	Selects slot 3 for the LDO2 to be enabled in at power up.																																								
			-	100	Selects slot 4 for the LDO2 to be enabled in at power up.																																								
			-	101	Selects slot 5 for the LDO2 to be enabled in at power up.																																								
				110	Selects slot 6 for the LDO2 to be enabled in at power up.																																								
			-	111	Selects slot 7 for the LDO2 to be enabled in at power up.																																								
2:0	LDO1_SEQ	000	R/W	The LDO1 sequenci	ng is selected by setting bits [2:0]																																								
				Code	Effect																																								
			-	000	Controlled through I2C by setting the LDO1_EN bit.																																								
				001	Selects slot 1 for the LDO1 to be enabled in at power up.																																								
			-	010	Selects slot 2 for the LDO1 to be enabled in at power up.																																								
			-	011	Selects slot 3 for the LDO1 to be enabled in at power up.																																								
			-	100	Selects slot 4 for the LDO1 to be enabled in at power up.																																								
		-		101	Selects slot 5 for the LDO1 to be enabled in at power up.																																								
			-	111	Selects slot 7 for the LDO1 to be enabled in at power up.																																								

Table 28. REGISTER DETAILS - 0x0D LDO34_SEQ

	0x0D LDC	34_SEQ		Default = 00000000																																		
Bit	Name	Default	Туре		Description																																	
7:6	UNUSED																																					
5:3	LDO4_SEQ	000	R/W	The LDO4 sequenci	ng is selected by setting bits [2:0]																																	
				Code	Effect																																	
			-	000	Controlled through I2C by setting the LDO4_EN bit.																																	
			-	001	Selects slot 1 for the LDO4 to be enabled in at power up.																																	
			-	010	Selects slot 2 for the LDO4 to be enabled in at power up.																																	
			-	011	Selects slot 3 for the LDO4 to be enabled in at power up.																																	
				100	Selects slot 4 for the LDO4to be enabled in at power up.																																	
			-	101	Selects slot 5 for the LDO4 to be enabled in at power up.																																	
					-	110	Selects slot 6 for the LDO4 to be enabled in at power up.																															
			-	111	Selects slot 7 for the LDO4 to be enabled in at power up.																																	
2:0	LDO3_SEQ	000	R/W	The LDO3 sequenci	ng is selected by setting bits [2:0]																																	
				Code	Effect																																	
				000	Controlled through I2C by setting the LDO3_EN bit.																																	
			-	001	Selects slot 1 for the LDO3 to be enabled in at power up.																																	
				010	Selects slot 2 for the LDO3 to be enabled in at power up.																																	
			-	011	Selects slot 3 for the LDO3 to be enabled in at power up.																																	
							100	Selects slot 4 for the LDO3 to be enabled in at power up.																														
				-				101	Selects slot 5 for the LDO3 to be enabled in at power up.																													
		-																																				
				111	Selects slot 7 for the LDO3 to be enabled in at power up.																																	

Table 29. REGISTER DETAILS – 0x0E SEQUENCING

	0x0E SEQU	JENCING			Default = 00000000		
Bit	Name	Default	Туре		Description		
7:6	SEQ_SPEED	00	R/W	Code	Period per Slot		
				00	500 μs		
				01	1.0 ms		
				10	1.5 ms		
				11	2.0 ms		
5:4	SEQ_CONTR	00	W1CLR	Code	Effect		
	ŌL			00	Default		
				01	Starts a converter power up sequence.		
				10	Starts a converter shutdown sequence.		
				11	Bit configuration is ignored		
				Note: The b	its will always clear immediately when written to and always readback 00.		
3	SEQ_ON 0	0 Read	Code	Effect			
				0	Indicates that the sequencing is not in process		
						1	Indicates that the sequencing is executing and somewhere between the start of slot 1 and the end of slot 7. The bit remains a 1 until slot 7 has completed at start-up or slot 1 has finished at shutdown, regardless of what slots are used.
				This bit is a rea	ad only status bit to indicate the sequencing is on.		
2:0	SEQ_COUNT	000	Read	Code	Slot		
				000	Indicates sequencing has completed or not started.		
				001	Indicates was in slot 1 during register read		
				010	Indicates was in slot 2 during register read		
				011	Indicates was in slot 3 during register read		
				100	Indicates was in slot 4 during register read		
				101	Indicates was in slot 5 during register read		
				110	Indicates was in slot 6 during register read		
				111	Indicates was in slot 7 during register read		
				These reg	ister bits provide the status of the sequencing.		

Table 30. REGISTER DETAILS – 0x0F DISCHARGE

	0x0F DISCH	ARGE			Default = 00111111	
Bit	Name	Default	Туре		Description	
7	BUCK_LOAD	0	R/W	Code	Effect	
				0	Buck internal load is removed from output.	
				1	Buck internal load is applied to the output during PFM operation.	
6	BOOST_LOAD	0	R/W	Code	Effect	
				0	Boost internal load is removed from output.	
				1	Boost internal load is applied to the output during PFM operation.	
5	LDO4_DIS	1	R/W	Code	Effect	
				0	LDO4 Active Discharge feature is disabled. Pull down will not be activated when LDO4 is disabled by any event.	
				1	LDO4 Active Discharge feature is enabled. Pull down will be activated when LDO4 is disabled by HWEN going low or LDO4_EN = 0 or a Sequenced shutdown or in an OVP event.	
4	LDO3_DIS	1	R/W	Code	Effect	
				0	LDO3 Active Discharge feature is disabled. Pull down will not be activated when LDO3 is disabled by any event.	
				1	LDO3 Active Discharge feature is enabled. Pull down will be activated when LDO3 is disabled by HWEN going low or LDO3_EN = 0 or a Sequenced shutdown or in an OVP event.	
3	LDO2_DIS	1	R/W	Code	Effect	
					0	LDO2 Active Discharge feature is disabled. Pull down will not be activated when LDO2 is disabled by any event.
				1	LDO2 Active Discharge feature is enabled. Pull down will be activated when LDO2 is disabled by HWEN going low or LDO2_EN = 0 or a Sequenced shutdown or in an OVP event.	
2	LDO1_DIS	1	R/W	Code	Effect	
				0	LDO1 Active Discharge feature is disabled. Pull down will not be activated when LDO1 is disabled by any event.	
				1	LDO1 Active Discharge feature is enabled. Pull down will be activated when LDO1 is disabled by HWEN going low or LDO1_EN = 0 or a Sequenced shutdown or in an OVP event.	
1	BOOST_DIS	1	R/W	Code	Effect	
				0	Boost Active Discharge feature is disabled. Pull down will not be activated when Boost is disabled by any event.	
				1	Boost Active Discharge is enabled and output is discharged by internal resistor when the Boost is disabled by BSTEN going low or BST_EN0 = 0 or in an OVP event.	
0	BUCK_DIS	1	R/W	Code	Effect	
				0	Buck Active Discharge feature is disabled. Pull down will not be activated when Buck is disabled by any event.	
					1	Buck Active Discharge feature is enabled. Pull down will be activated when Buck is disabled by HWEN going low or BUCK_EN = 0 or a Sequenced shutdown or in an OVP event.

Table 31. REGISTER DETAILS – 0x10 RESET

	0x10 RI	ESET			Default = 0000000			
Bit	Name	Default	Туре		Description			
7	UNUSED							
6:3	SOFT_RESET	0000	Write		Reset condition: 0			
				Code	Effect			
				1011	Writing a "1011" begins a soft reset of the device I2C registers to their default values. This bit is cleared upon execution of the Reset function.			
					Any other value than "1011" will be ignored.			
2:1	UNUSED							
0	FLT_SD_B	0	R/W	Code	Effect			
				0	Converter is shutdown if an OVP, UVP or OCP event occurs.			
							1	Converter is not shutdown if an OVP, UVP or OCP event occurs.
				to enabling any – If a hard short	ion is desired, FLT_SD_B should be set to "1" prior converters after a Power-On-Reset occurs on either the buck or boost output, the nutdown to protect itself even if the FLT_SD_B bit is			

Table 32. REGISTER DETAILS – 0x11 INTERRUPT1

	0x11 INTER	RUPT1			Default = 00000000
Bit					Description
7	LDO4_OVP_INT	0	R/CLR	Code	Effect
				0	Clear
				1	Over-Voltage event detected on LDO4 output or the voltage has fallen below the OVP_Falling threshold.
6	LDO3_OVP_INT	0	R/CLR	Code	Effect
				0	Clear
				1	Over Voltage event detected on LDO3 output or the voltage has fallen below the OVP_Falling threshold.
5	LDO2_OVP_INT	0	R/CLR	Code	Effect
				0	Clear
				1	Over-Voltage event detected on LDO2 output or the voltage has fallen below the OVP_Falling threshold.
4	LDO1_OVP_INT	0	R/CLR	Code	Effect
				0	Clear
				1	Over-Voltage event detected on LDO1 output or the voltage has fallen below the OVP_Falling threshold.
3	LDO4_UVP_INT	0	R/CLR	Code	Effect
				0	Clear
				1	Under-Voltage event detected on LDO4 output or the voltage has risen above the UVP_Rising threshold.
2	LDO3_UVP_INT	0	R/CLR	Code	Effect
				0	Clear
				1	Under-Voltage event detected on the output of LDO3 or the voltage has risen above the UVP_Rising threshold.
1	LDO2_UVP_INT	0	R/CLR	Code	Effect
				0	Clear
			1	Under-Voltage event detected on LDO2 output or the voltage has risen above the UVP_Rising threshold.	
0	LDO1_UVP_INT	0	R/CLR	Code	Effect
				0	Clear
				1	Under-Voltage event detected on LDO1 output or the voltage has risen above the UVP_Rising threshold.

Table 33. REGISTER DETAILS – 0x12 INTERRUPT2

	0x12 INTER	RUPT2		Default = 0000000			
Bit	,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,				Description		
7	BST_OVP_INT	0	R/CLR	Code	Effect		
				0	Clear		
				1	Over–Voltage event detected on the Boost output or the voltage has fallen below the OVP_Falling threshold.		
6	BUCK_OVP_IN	0	R/CLR	Code	Effect		
	I			0	Clear		
				1	Over–Voltage event detected on the Buck output or the voltage has fallen below the OVP_Falling threshold.		
5	BST_UVP_INT	0	R/CLR	Code	Effect		
				0	Clear		
				1	Under–Voltage event detected on on the Boost output or the voltage has risen above the UVP_Rising threshold.		
4	BUCK_UVP_IN	0	R/CLR	Code	Effect		
	I			0	Clear		
				1	Under-Voltage event detected on on the Buck output or the voltage has risen above the UVP_Rising threshold.		
3	LDO4_OCP_IN	0	R/CLR	Code	Effect		
	I			0	Clear		
				1	Over-Current event detected on LDO4 output or that a successful restart has occurred after an OCP event.		
2	LDO3_OCP_IN T	0	R/CLR	Code	Effect		
	I			0	Clear		
				1	Over-Current event detected on LDO3 output or that a successful restart has occurred after an OCP event.		
1	LDO2_OCP_IN	0	R/CLR	Code	Effect		
	Т			0	Clear		
				1	Over-Current event detected on LDO2 output or that a successful restart has occurred after an OCP event.		
0	LDO1_OCP_IN	0	R/CLR	Code	Effect		
				0	Clear		
				1	Over-Current event detected on LDO1 output or that a successful restart has occurred after an OCP event.		

Table 34. REGISTER DETAILS – 0x13 INTERRUPT3

	0x13 INTERR	UPT3			Default = 0000000	
Bit	Name	Default	Туре		Description	
7	BST_IPK_INT	0	R/CLR	Code	Effect	
				0	Clear	
				1	Boost Peak Current limit reached or the Boost successfully completed a restart after a Peak Current fault.	
6	BUCK_IPK_INT	0	R/CLR	Code	Effect	
				0	Clear	
				1	Buck Peak Current reached or the Buck successfully completed a restart after a Peak Current fault.	
5	APVIN_UVLO_INT	0	R/CLR	Code	Effect	
				0	Normal operation	
				1	Indicates that the AV_{IN} and/or PV_{IN} power fell below the UVLO input threshold or that the supplies have risen above the rising thresholds after a UVLO fault.	
				Reading the the	e associated status bit provides present state of the input voltage.	
4	LDO12_UVLO_INT	LDO12_UVLO_INT	0	R/CLR	Code	Effect
				0	Normal operation	
						1
			Reading the the	e associated status bit provides present state of the input voltage.		
3	LDO3_UVLO_INT	0	0 R/CLR	Code	Effect	
				0	Normal Operation	
				1	Indicates that the V _{IN3} fell below the UVLO threshold while LDO3 was enabled or that the supply has risen above the rising thresholds after a UVLO fault.	
				Reading the the	e associated status bit provides present state of the input voltage.	
2	LDO4_UVLO_INT	0	R/CLR	Code	Effect	
				0	Normal Operation	
				1	Indicates V _{IN4} fell below the UVLO threshold while LDO4 where enabled or that the supply has risen above the rising thresholds after a UVLO fault.	
				Reading the the	e associated status bit provides present state of the input voltage.	
1	TSD_INT	0	R/CLR	Code	Effect	
				0	Clear	
				1	A Thermal Shutdown event detected or that the temperature has fallen below the hysteresis level.	
0	TSD_WRN_INT	0	R/CLR	Code	Effect	
				0	Clear	
				1	Thermal Shutdown Warning threshold was surpassed or that the temperature has fallen below the hysteresis level.	

Table 35. REGISTER DETAILS – 0x14 STATUS1

	0x14 STATUS1			Default = 0000000		
Bit	Name	Default	Туре		Description	
7	LDO4_OVP_STAT	0	Read	Code	Effect	
				0	Clear	
				1	An Over–Voltage condition exists on LDO4 output	
6	LDO3_OVP_STAT	0	Read	Code	Effect	
				0	Clear	
				1	An Over–Voltage condition exists on LDO3 output	
5	LDO2_OVP_STAT	0	Read	Code	Effect	
				0	Clear	
				1	An Over-Voltage condition exists on LDO2 output	
4	LDO1_OVP_STAT	0	Read	Code	Effect	
				0	Clear	
				1	An Over-Voltage condition exists on LDO1 output	
3	LDO4_UVP_STAT	0	Read	Code	Effect	
				0	Clear	
				1	An Under-Voltage condition exists on LDO4 output	
2	LDO3_UVP_STAT	0 Read	Code	Effect		
				0	Clear	
				1	An Under-Voltage condition exists on the output o LDO3	
1	LDO2_UVP_STAT	0	Read	Code	Effect	
				0	Clear	
				1	An Under-Voltage condition exists on LDO2 output	
0	LDO1_UVP_STAT	0	Read	Code	Effect	
				0	Clear	
				1	An Under-Voltage condition exists on LDO1 outpu	

Table 36. REGISTER DETAILS – 0x15 STATUS2

	0x15 STATU	JS2			Default = 0000000
Bit	Name	Default	Туре		Description
7	BST_OVP_STAT	0	Read	Code	Effect
				0	Clear
				1	An Over-Voltage condition exists on the Boost output.
6	BUCK_OVP_STAT	0	Read	Code	Effect
				0	Clear
				1	An Over–Voltage condition exists on the Buck output.
5	BST_UVP_STAT	0	Read	Code	Effect
				0	Clear
				1	An Under-Voltage condition exists on the Boost output.

4	BUCK_UVP_STAT	0	Read	Code	Effect
				0	Clear
				1	An Under-Voltage condition exists on the Buck output.
3	LDO4_OCP_STAT	0	Read	Code	Effect
				0	Clear
				1	An Over-Current condition exists on LDO4 output
2	LDO3_OCP_STAT	0	0 Read	Code	Effect
				0	Clear
				1	An Over-Current condition exists on LDO3 output
1	LDO2_OCP_STAT	0	Read	Code	Effect
				0	Clear
				1	An Over-Current condition exists on LDO2 output
0	LDO1_OCP_STAT	0	Read	Code	Effect
				0	Clear
				1	An Over-Current condition exists on LDO1 output

Table 36. REGISTER DETAILS – 0x15 STATUS2

Table 37. REGISTER DETAILS - 0x16 STATUS3

	0x16 STATU	S3		Default = 00000000							
Bit	Name	Default	Туре		Description						
7	BST_IPK_STAT	0	Read	Code	Effect						
			F	0	Clear						
			F	1	Boost is hitting the Peak Current limit.						
6	BUCK_IPK_STAT	0	Read	Code	Effect						
				0	Clear						
				1	The Buck is hitting the Peak Current limit						
5	APVIN_UVLO_STAT	0	Read		Reset condition: 0						
				Code	Effect						
				0	Normal Operation						
				1	Indicates AV _{IN} and/or PV _{IN} are below the UVLO threshold.						
4	LDO12_UVLO_STAT 0	LDO12_UVLO_STAT	LDO12_UVLO_STAT	LDO12_UVLO_STAT	LDO12_UVLO_STAT	LDO12_UVLO_STAT	LDO12_UVLO_STAT	0	Read	Code	Effect
			ľ	0	Normal Operation						
				1	indicates V _{IN12} is below the UVLO threshold while LDO1 and/or LDO2 have been enabled.						
3	LDO3_UVLO_STAT	0	0 Read	Code	Effect						
							0	Normal Operation			
			-	1	Indicates V _{IN3} power rail is below the UVLO threshold while LDO3 is enabled.						
2	LDO4_UVLO_STAT	0	Read	Code	Effect						
			F	0	Normal Operation						
				1	Indicates V _{IN4} is below the UVLO threshold while LDO4 is been commanded to be enabled.						
1	TSD_STAT	0	Read	Code	Effect						
			ŀ	0	Clear						
			ŀ	1	The device is in thermal shutdown (TSD)						
0	TSD_WRN_STAT	0	Read	Code	Effect						
			ŀ	0	Clear						
			Ē	1	The temperature is above the Thermal Shutdown Warning threshold and shutdown is impending.						

Table 38. REGISTER DETAILS – 0x17 MINT1

	0x17 MINT1				Default = 0000000
Bit	Name	Default	Туре		Description
7	MASK_LDO4_OVP	0	R/W	Code	Effect
				0	No masking of interrupt.
				1	INTB pin is not pulled low when LDO4 Over–Voltage interrupt occurs.
6	MASK_LDO3_OVP	0	R/W	Code	Effect
				0	No masking of interrupt.
				1	INTB pin is not pulled low when LDO3 Over–Voltage interrupt occurs.

Table 38. REGISTER DETAILS – 0x17 MINT1

	0x17 MINT	1			Default = 0000000		
Bit	Name	Default	Туре		Description		
5	MASK_LDO2_OVP	0	R/W	Code	Effect		
				0	No masking of interrupt.		
				1	INTB pin is not pulled low when LDO2 Over–Voltage interrupt occurs.		
4	MASK_LDO1_OVP	0	R/W	Code	Effect		
				0	No masking of interrupt.		
				1	INTB pin is not pulled low when LDO1 Over–Voltage interrupt occurs.		
3	MASK_LDO4_UVP	0	R/W	Code	Effect		
				0	No masking of interrupt.		
				1	INTB pin is not pulled low when LDO4 Under-Voltage interrupt occurs.		
2	MASK_LDO3_UVP	0	R/W	Code	Effect		
				0	No masking of interrupt.		
				1	INTB pin is not pulled low when LDO3 Under-Voltage interrupt occurs.		
1	MASK_LDO2_UVP	0	R/W	Code	Effect		
				0	No masking of interrupt.		
				1	INTB pin is not pulled low when LDO2 Under-Voltage interrupt occurs.		
0	MASK_LDO1_UVP	0	R/W	Code	Effect		
				0	No masking of interrupt.		
				1	INTB pin is not pulled low when LDO1 Under–Voltage interrupt occurs.		

Table 39. REGISTER DETAILS - 0x18 MINT2

	0x18 MINT	2			Default = 0000000		
Bit	Name	Default	Туре		Description		
7	MASK_BST_OVP	0	R/W	Code	Effect		
				0	No masking of interrupt.		
				1	INTB pin is not pulled low when Boost Over-Voltage interrupt occurs.		
6	MASK_BUCK_OVP	0	R/W	Code	Effect		
				0	No masking of interrupt.		
				1	INTB pin is not pulled low when Buck Over-Voltage interrupt occurs.		
5	MASK_BST_UVP	0	R/W	Code	Effect		
				0	No masking of interrupt.		
				1	INTB pin is not pulled low when Boost Under-Voltage interrupt occurs.		
4	MASK_BUCK_UVP	0	R/W	Code	Effect		
				0	No masking of interrupt.		
				1	INTB pin is not pulled low when Buck Under-Voltage interrupt occurs.		

Table 39. REGISTER DETAILS - 0x18 MINT2

	0x18 MINT	2			Default = 0000000
Bit	Name	Default	Туре		Description
3	MASK_LDO4_OCP	0	R/W	Code	Effect
				0	No masking of interrupt.
				1	INTB pin is not pulled low when LDO4 Over-Current interrupt occurs.
2	MASK_LDO3_OCP	0	R/W	Code	Effect
				0	No masking of interrupt.
				1	INTB pin is not pulled low when LDO3 Over-Current interrupt occurs.
1	MASK_LDO2_OCP	0	R/W	Code	Effect
				0	No masking of interrupt.
				1	INTB pin is not pulled low when LDO2 Over-Current interrupt occurs.
0	MASK_LDO1_OCP	0	R/W	Code	Effect
				0	No masking of interrupt.
				1	INTB pin is not pulled low when LDO1 Over-Current interrupt occurs.

Table 40. REGISTER DETAILS - 0x19 MINT3

	0x19 MINT3	5		Default = 0000000		
Bit	Name	Default	Туре		Description	
7	MASK_BST_IPK	0	R/W	Code	Effect	
				0	No masking of interrupt.	
				1	INTB pin is not pulled low when Boost Peak Current limit interrupt occurs.	
6	MASK_BUCK_IPK	0	R/W	Code	Effect	
				0	No masking of interrupt.	
				1	INTB pin is not pulled low when Buck Peak Current limit interrupt occurs.	
5	MASK_APVIN_UVLO	0	R/W	Code	Effect	
				0	No masking of interrupt.	
				1	INTB pin is not pulled low when AV _{IN} /PV _{IN} Input Power Under Voltage interrupt occurs.	
4	MASK_LDO12_UVLO	0	R/W	Code	Effect	
				0	No masking of interrupt.	
				1	INTB pin is not pulled low when V _{IN12} Input Power Under Voltage interrupt occurs.	
3	MASK_LDO3_UVLO	0	R/W	Code	Effect	
				0	No masking of interrupt.	
				1	INTB pin is not pulled low when V _{IN3} Input Power Under Voltage interrupt occurs.	
2	MASK_LDO4_UVLO	0	R/W	Code	Effect	
				0	No masking of interrupt.	
				1	INTB pin is not pulled low when V _{IN4} Input Power Under Voltage interrupt occurs.	

Table 40. REGISTER DETAILS - 0x19 MINT3

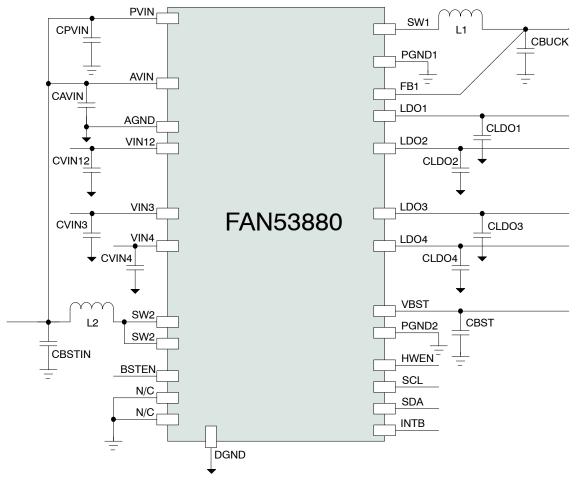
0x19 MINT3				Default = 0000000		
Bit	Name	Default	Туре	Description		
1	MASK_TSD	0	R/W	Code Effect		
				0	No masking of interrupt.	
				1	INTB pin is not pulled low when a Thermal Shutdown interrupt occurs.	
0	MASK_TSD_WRN	0	R/W	Code	Effect	
				0	No masking of interrupt.	
				1	INTB Pin is not pulled low when a Thermal Shutdown Warning interrupt occurs.	

Table 41. REGISTER DETAILS – 0x1A STATUS4

	0x1A STAT	'US4		Default = 00000000		
Bit	Name	Default	Туре	Description		
7	UNUSED					
6	CHIP_SUSD	0	Read	Code	Effect	
				0	Chip normal state	
				1	The entire chip has been suspended due to a global fault condition.	
5	BOOST_SUSD	0	Read	Code	Effect	
				0	Boost normal state	
				1	Boost converter has been suspended due to a fault condition.	
4	BUCK_SUSD	0	Read	Code	Effect	
				0	Buck in normal state.	
				1	Buck converter has been suspended due to a fault condition.	
3	LDO4_SUSD	0	Read	Code	Effect	
				0	LDO4 in normal state.	
				1	LDO4 converter has been suspended due to a fault condition.	
2	LDO3_SUSD	0	Read	Code	Effect	
				0	LDO3 in a normal state	
				1	LDO3 converter has been suspended due to a fault condition.	
1	LDO2_SUSD	0	Read	Code	Effect	
				0	LDO2 in normal state	
				1	LDO2 converter has been suspended due to a fault condition.	
0	LDO1_SUSD	0	Read	Code	Effect	
				0	LDO1 is in normal state	
				1	LDO1 converter has been suspended due to a fault condition.	

APPLICATION CIRCUIT

Application Circuit Diagram





Application Circuit Components

Table 42. RECOMMENDED EXTERNAL COMPONENTS

Component	Manufacturer	Part Number	Value	Case Size	Voltage Rating
C _{PVIN}	TDK	C1005X5R0J106M050BC	10 μF	0402/1005 (1.0mm x 0.5mm)	6.3 V
C _{BUCK}	TDK	C1005X5R0J106M050BC	10 μF	0402/1005 (1.0mm x 0.5mm)	6.3 V
C _{BSTIN}	TDK	C1005X5R0J106M050BC	10 μF	0402/1005 (1.0mm x 0.5mm)	6.3 V
C _{BST}	Murata	GRM188R61A226ME15D	22 μF	0603/1608 (1.6mm x 0.8mm)	10 V
C _{VIN12} , C _{VIN3} , C _{VIN4}	Murata	GRM033R60J225ME47D	2.2 μF	0201/0603 (0.6mm x 0.3mm)	6.3 V
C _{LDO1} , C _{LDO2} , C _{LDO3} , C _{LDO4}	Murata	GRM033R60J225ME47D	2.2 μF	0201/0603 (0.6mm x 0.3mm)	6.3 V
C _{AVIN}	TDK	C1005X5R0J475M	4.7 μF	0402/1005 (1.0mm x 0.5mm)	6.3 V
L1	Taiyo Yuden	MEKK2016T1R0M	1.0 μH, I _{SAT} = 4.0 A, R _{DC} = 50 mΩ	0806/2016 (2.0mm x 1.6mm x 1.0mm)	
L2	Taiyo Yuden	MEKK2012HR47M	0.47 μH, I _{SAT} = 5.3 A, R _{DC} = 25 mΩ	0805/2012 (2.0mm x 1.2mm x 1.0mm)	

Recommended Alternative Components

Table 43. ALTERNATIVE COMPONENTS

Component	Manufacturer	Part Number	Value	Case Size	Voltage Rating
C _{PVIN}	Taiyo Yuden	JMK105CBJ106MV	10 μF	0402/1005 (1.0mm x 0.5mm)	6.3 V
C _{BUCK}	Taiyo Yuden	JMK105CBJ106MV	10 μF	0402/1005 (1.0mm x 0.5mm)	6.3 V
C _{BSTIN}	Taiyo Yuden	JMK105CBJ106MV	10 μF	0402/1005 (1.0mm x 0.5mm)	6.3 V
C _{BST}	Semco	CL10A226MP8NUXE	22 μF	0603/1608 (1.6mm x 0.8mm)	10 V
C _{LDO1} , C _{LDO2} , C _{LDO3} , C _{LDO4}	Semco	CLO3A225MQCRNC	2.2 μF	0201/0603 (0.6mm x 0.3mm)	6.3 V
L1	TDK	TFM201610GHM-1R0MTAA	1.0 μH, I _{SAT} = 3.8 A, R _{DC} = 50 mΩ	2016 (2.0mm x 1.6mm x 1.0mm)	

APPLICATION GUIDELINES

Buck Input Capacitor Considerations

A minimum capacitance of 2.2 μ F with ceramic dielectric, input capacitor should be placed as close as possible between the V_{IN} pin and GND to minimize the parasitic inductance. If a long wire is used to bring power to the IC, additional "bulk" capacitance (electrolytic or tantalum) should be placed between C_{IN} and the power source lead to reduce the ringing that can occur between the inductance of the power source leads and C_{IN}.

The effective capacitance value decreases as $V_{IN} \mbox{ increases due to DC bias effects.}$

Buck Output Capacitor Considerations

FAN53880 uses a 22 μ F, 0402 (1005 metric) for an output capacitor. The effective capacitance of ceramic capacitors decrease as the bias voltage across the capacitor increases. Increasing the output capacitor has no effect on loop stability and therefore to overcome the effects of bias voltage across C_{OUT}, the capacitor value can be increased to reduce the output voltage ripple and/or to improve transient response. Output voltage ripple is defined as:

$$\Delta V_{\text{OUT}} = \Delta I_{\text{L}} \left[\frac{f_{\text{SW}} \cdot C_{\text{OUT}} \cdot \text{ESR}^2}{2 \cdot \text{D} \cdot (1 - \text{D})} + \frac{1}{8 \cdot f_{\text{SW}} \cdot C_{\text{OUT}}} \right]$$

Buck Inductor Considerations

The output inductor must meet both the required inductance and the energy-handling capability of the application. The inductor value affects average current limit,

Table 44.

the PWM-to-PFM transition point, output voltage ripple, and efficiency.

The ripple current (ΔI) of the regulator is:

$$\Delta I \approx \frac{V_{OUT}}{V_{IN}} \cdot \left(\frac{V_{IN} - V_{OUT}}{L \cdot f_{SW}} \right)$$

The maximum average load current, $I_{MAX(LOAD)}$, is related to the peak current limit, $I_{LIM(PK)}$, by the ripple current, given by:

$$I_{MAX(LOAD)} = I_{LIM(PK)} - \frac{\Delta I}{2}$$

The FAN53880 is optimized for operation with L = 1.0uH. The inductor should be rated to maintain at least 80% of its value at $I_{LIM(PK)}$. It is recommended to select an inductor where its saturation current is above the $I_{LIM(PK)}$ value. Efficiency is affected by the inductor DCR and inductance value. Decreasing the inductor value for a given physical size typically decreases the DCR; but because ΔI increases, the RMS current increases, as do the core and skin effect losses.

$$\Delta I \approx \frac{V_{\text{OUT}}}{V_{\text{IN}}} \cdot \left(\frac{V_{\text{IN}} - V_{\text{OUT}}}{L \cdot f_{\text{SW}}} \right)$$

The increased RMS current produces higher losses through the $R_{DS(ON)}$ of the IC MOSFETs, as well as the inductor DCR. Increasing the inductor value produces lower RMS currents, but degrades transient response. For a given physical inductor size, increased inductance usually results in an inductor with lower saturation current and higher DCR.

Inductor Value	I _{MAX(LOAD)}	ΔV _{OUT}	Transient Response	
Increase	Increase	Decrease	Degraded	
Decrease	Decrease	Increase	Improved	

Boost Input Capacitor Considerations

The 10 μ F ceramic 0402 (1005 metric) input capacitor should be placed as close as possible between the V_{IN} pin and GND to minimize the parasitic inductance. If a long wire is used to bring power to the IC, additional "bulk" capacitance (electrolytic or tantalum) should be placed (on Eval board) between C_{IN} and the power source lead to reduce the ringing that can occur between the inductance of the power source leads and C_{IN}.

The effective capacitance value decreases as $V_{IN} \mbox{ increases due to DC bias effects.}$

Boost Output Capacitor

Output voltage ripple is inversely proportional to C_{BST} . During t_{ON} , when the boost switch is on, all load current is supplied by C_{BST} . The maximum V_{RIPPLE} occurs when V_{IN} is minimum and I_{LOAD} is maximum.

It is recommended to use the capacitor shown in either the Recommended External Components or the Alternate Components table. If a different component is chosen, it is important that it's effective capacitance is equal to or greater than that of the Recommended Component. For better ripple performance, additional output capacitance can be added.

Boost Inductor Considerations

The FAN53880 employs a peak current limiting, so peak inductor current can reach 4 A for a short duration during overload conditions. Saturation effects causes the inductor current ripple to become higher under high loading, as only the peak of the inductor current ripple is controlled.

LDO Input Capacitor Considerations

If long wires are used to bring power to an evaluation board, additional "bulk" capacitance (electrolytic or tantalum) should be placed (on Eval board) between C_{IN} and the power source lead to reduce ringing that can occur between the inductance of the power source leads and C_{IN} .

The effective capacitance value decreases as V_{IN} increases due to DC bias effects. Adding additional capacitance to the minimum recommended ensures reliable operation.

LDO Output Capacitor Considerations

FAN53880 LDO's are tuned for high load capacitance of 2.2 to 26 μ F. Total capacitance on the LDO output that is outside this window may result in instability or as a minimum, the LDO not meeting the performance listed in the Electrical and System Characteristics tables. For instance: Adding additional capacitance can slow the soft start when the LDO is enabled but also improves transient response. The effective capacitance of ceramic capacitors decrease as the bias voltage across the capacitor increases.

Recommended Layout All Layer Layout

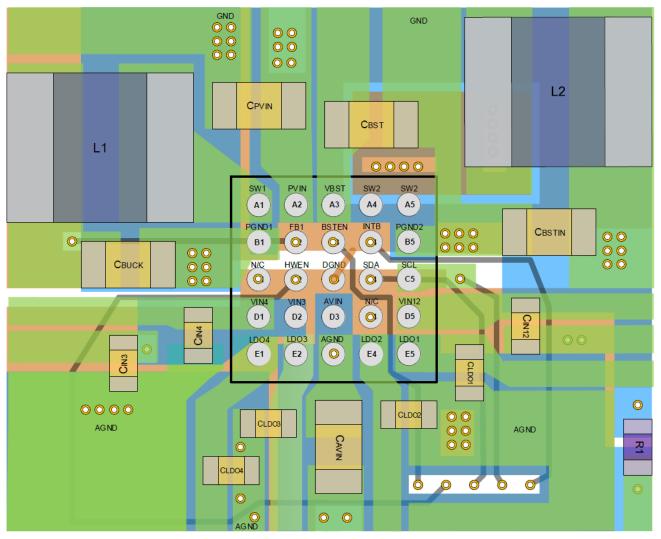


Figure 38. All Layer Layout



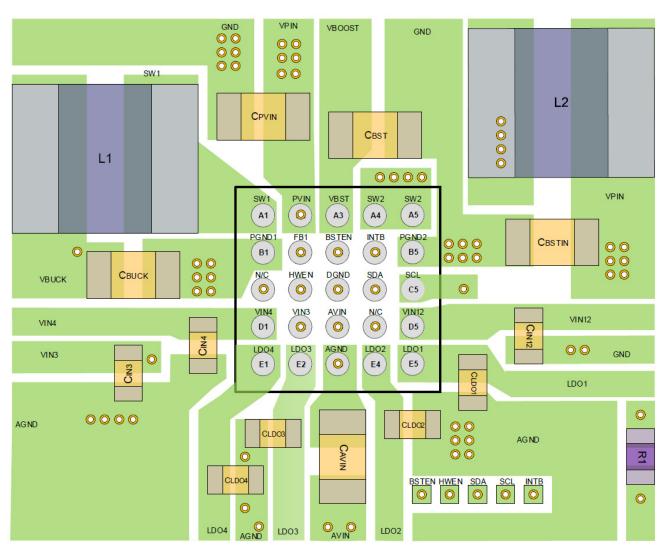


Figure 39. Layer 1

Layer 2, Ground Plane

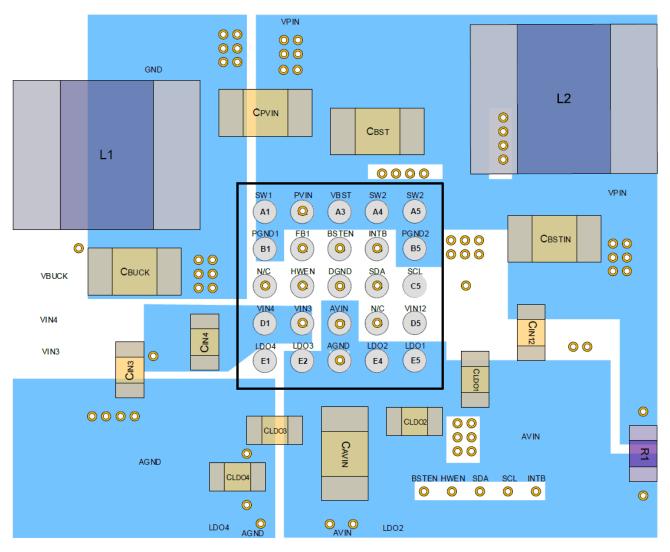


Figure 40. Layer 2, Ground Plane

Layer 3, Signal Plane

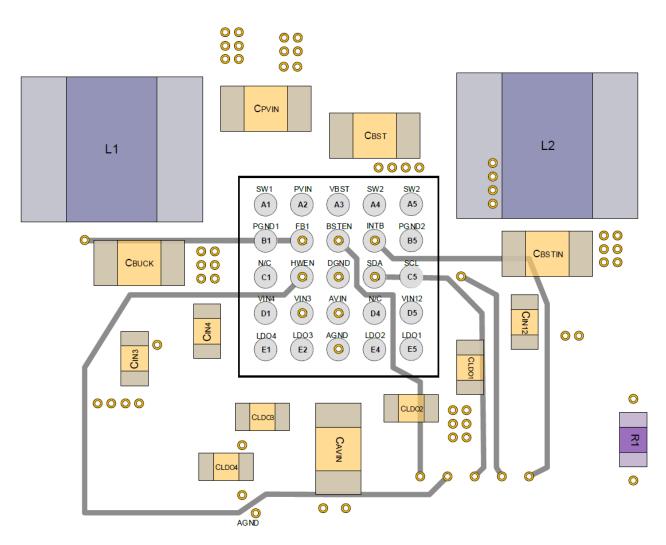


Figure 41. Layer 3, Signal Plane

Layer 4, Power Plane

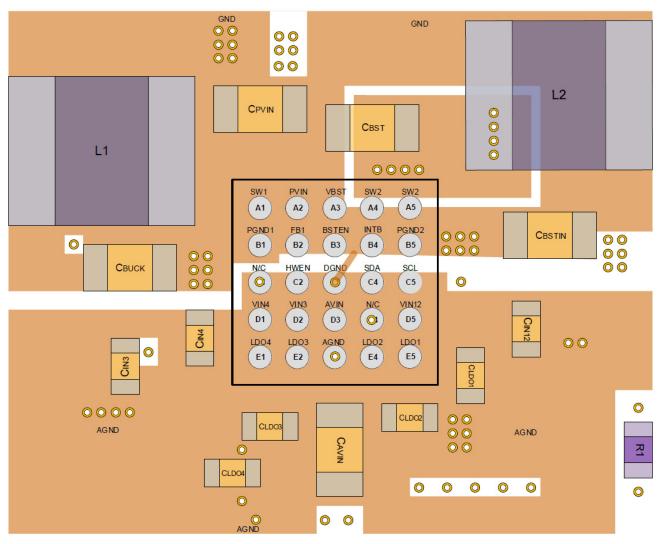


Figure 42. Layer 4, Power Plane

Layout Considerations

To minimize spikes for the buck at V_{OUT} , C_{OUT} must be placed as close as possible to PGND1 and VOUT, as shown in the recommended layout. For the boost, CIN should be located as close to PGND2 as possible to minimize the spikes and noise generated by the switching node LX2. For thermal reasons, it is suggested to maximize the pour area for all planes other than SW. Especially the ground pour should be set to fill all available PCB surface area and tied to internal layers with a cluster of thermal vias.

PACKAGE DIMENSIONS

WLCSP25 2.16x2.16x0.586 CASE 567QT ISSUE A

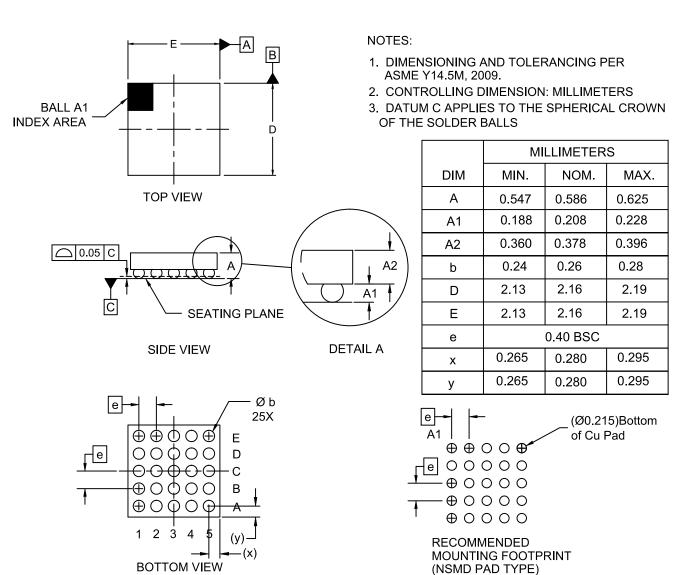


Table 45. PRODUCT SPECIFIC DIMENSIONS

Product	D (mm)	E (mm)	X (mm)	Y (mm)
FAN53880	2.16	2.16	0.08	0.08

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